

Scheme Report

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1 Background

2 Methods

2.1 Schemes

2.1.1 Single schemes

2.1.2 Ring schemes

2.1.3 Equal Angle

2.1.4 Tilt and Rotate

2.1.5 Spiral schemes

2.1.6 Hexagonal schemes

2.1.7 CLRGrid

2.1.8 Gaussian Quadrature

3 Results

3.1 Contour Plot Images

3.1.1 Single schemes

3.1.2 Ring schemes

3.1.3 Equal Angle

3.1.4 Tilt and Rotate

3.1.5 Spiral schemes

3.1.6 Hexagonal schemes

3.1.7 CLRGrid

3.1.8 Gaussian Quadrature

4 Discussion

5 Conclusions

6 Explicit Citations (to be deleted soon)

This paragraph is a placeholder to enumerate the citations that will be used in this report. [Cor] and [Bun15] are the 2 first citations that come by alphabetical convention. Next come [CR01], [CFCC20], and [CCPGH18]. This is followed by [CS01], [fMuE], [JAB⁺09], and [MW92]. Moving on, we have [Raa03] and [RWP08], accompanied by 2 works by the same author: [Rol20a] and [Rol20b]. As we move towards the end of the citations, we have [Sch04] and [Sha05] rounding out the list of citations used in this report. I'm adding an extra line so that we can get the *References* section on its own page.

References

[Bun15] H.J. Bunge. *Texture Analysis in Materials Science, Digital Edition*. Wolfratshausen, 2015.

- [CCPGH18] A. Creuziger, C. A. Calhoun, W. A. Poling, and T. Gnäupel-Herold. Assessment of Bias Errors Caused by Texture and Sampling Methods in Diffraction-Based Steel Phase Measurements. *Journal of Applied Crystallography*, 2018.
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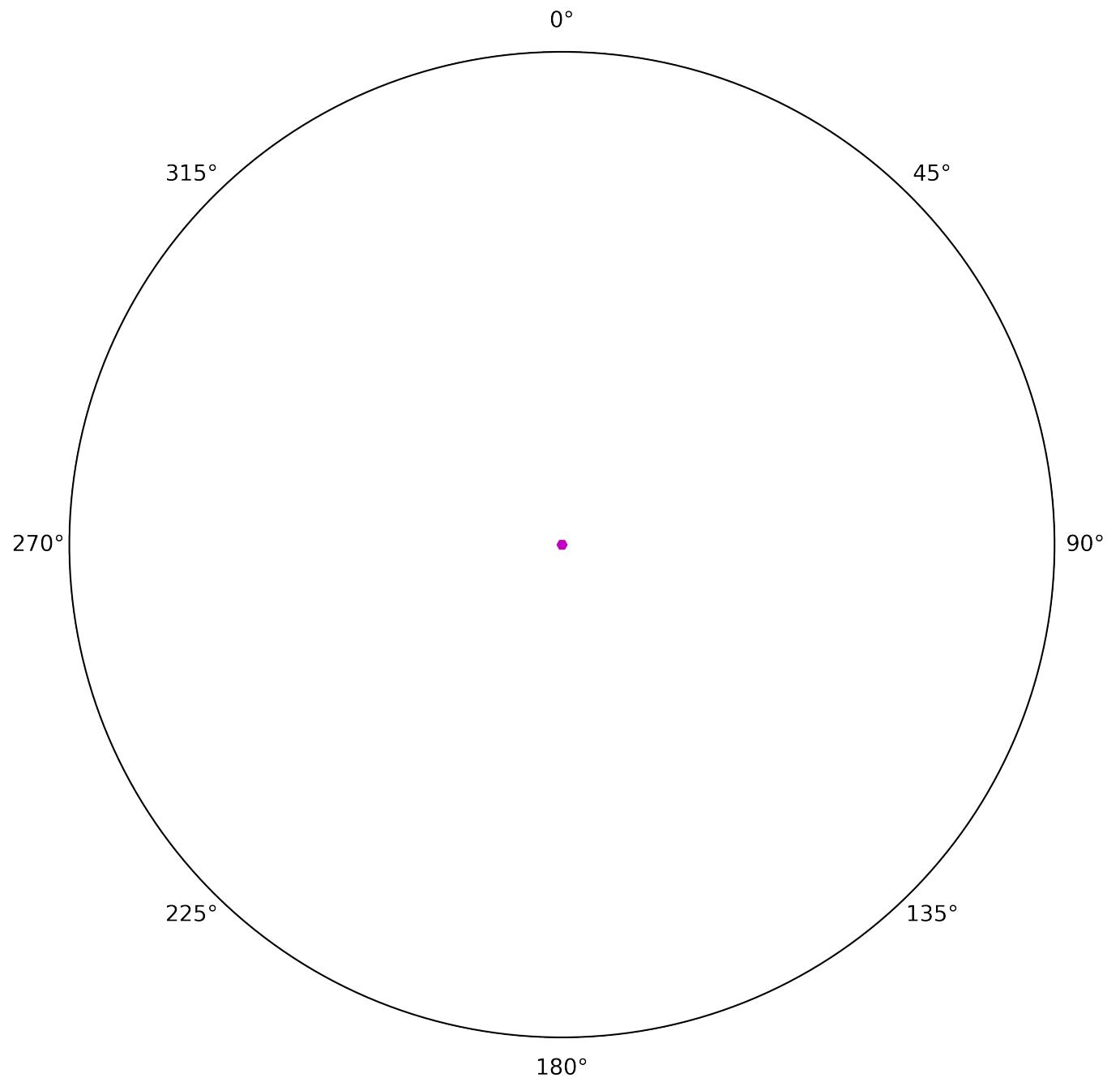


Figure 1: Sample Caption

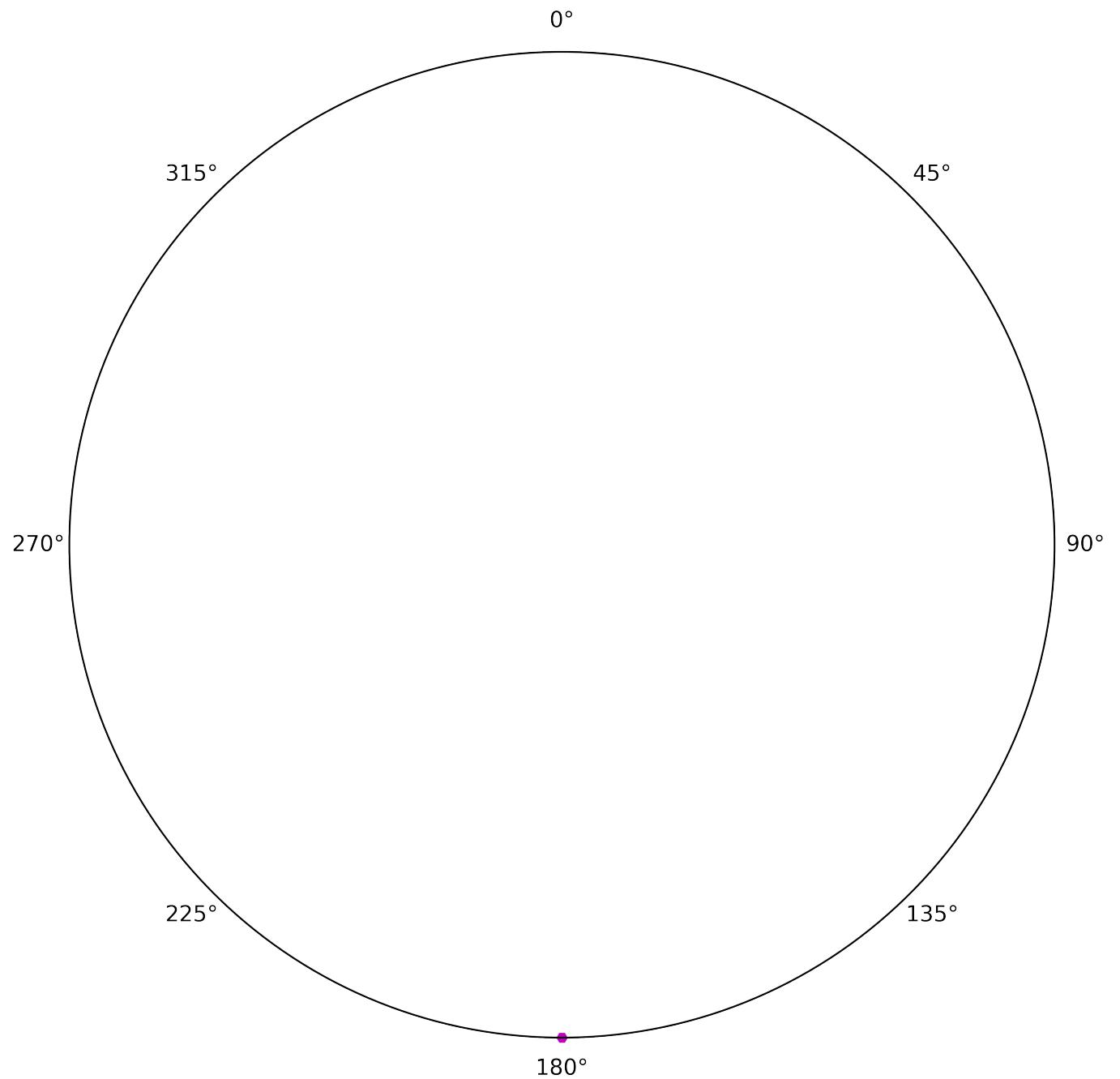


Figure 2: Sample Caption

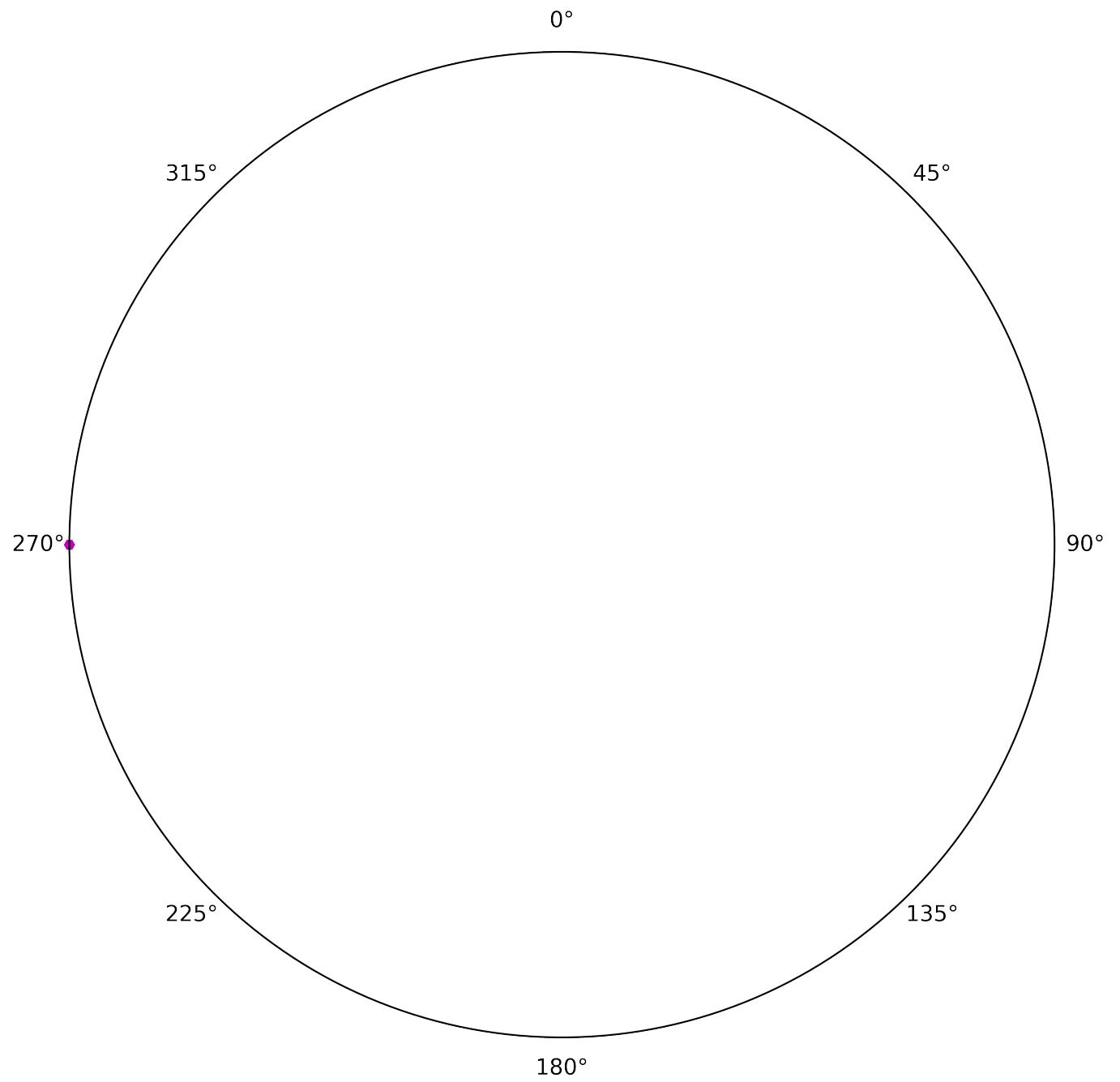


Figure 3: Sample Caption

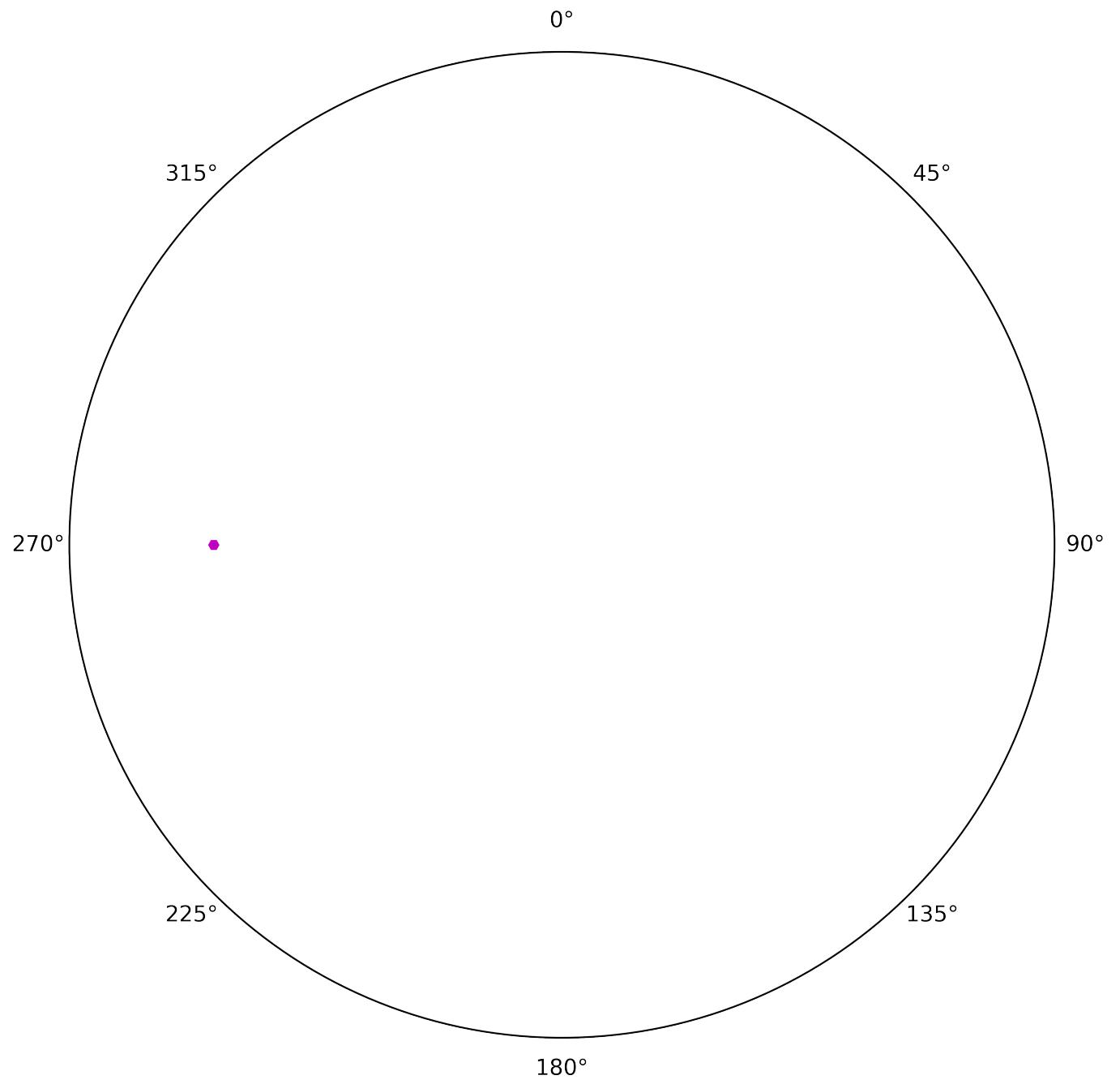


Figure 4: Sample Caption

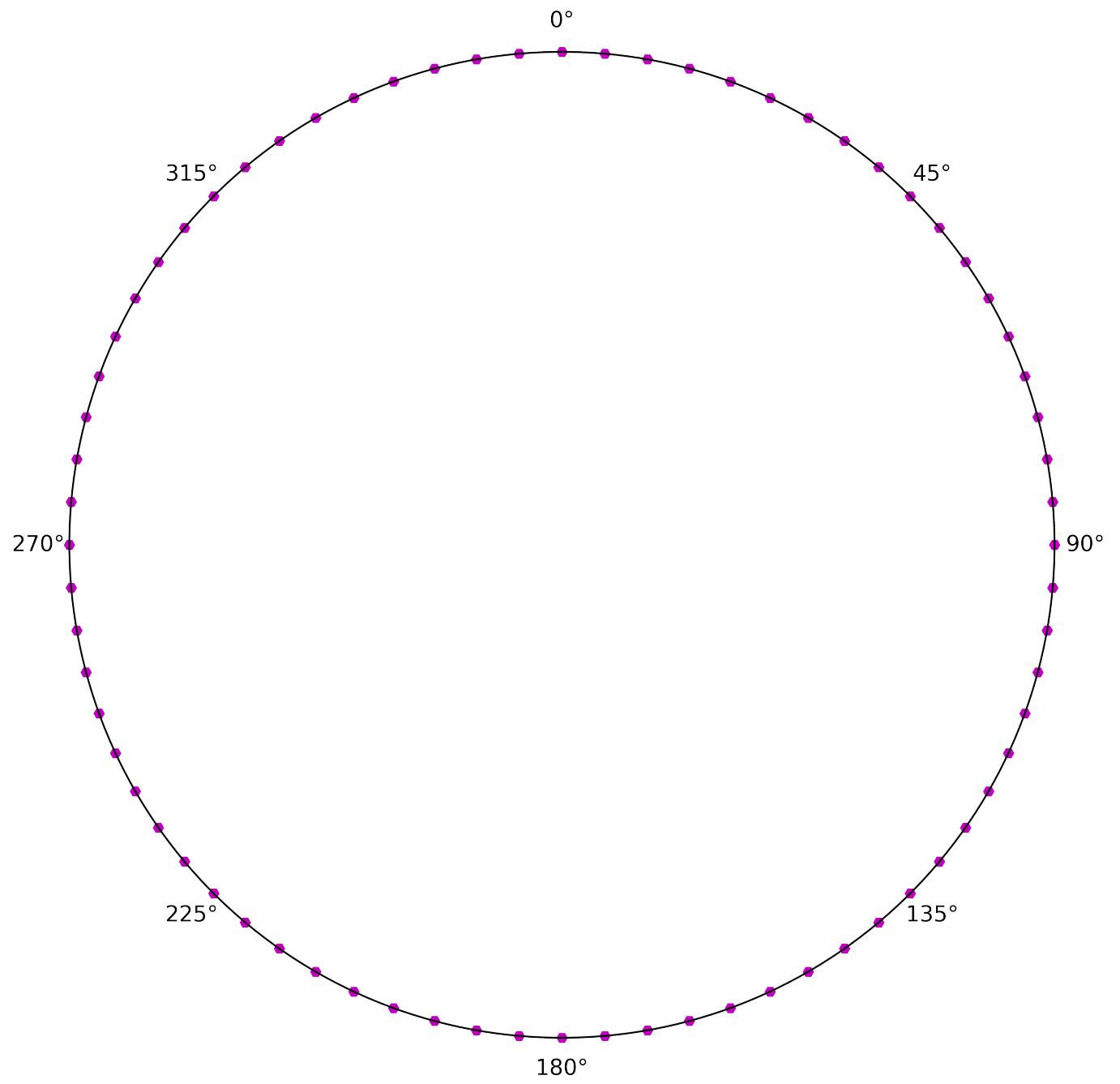


Figure 5: Sample Caption

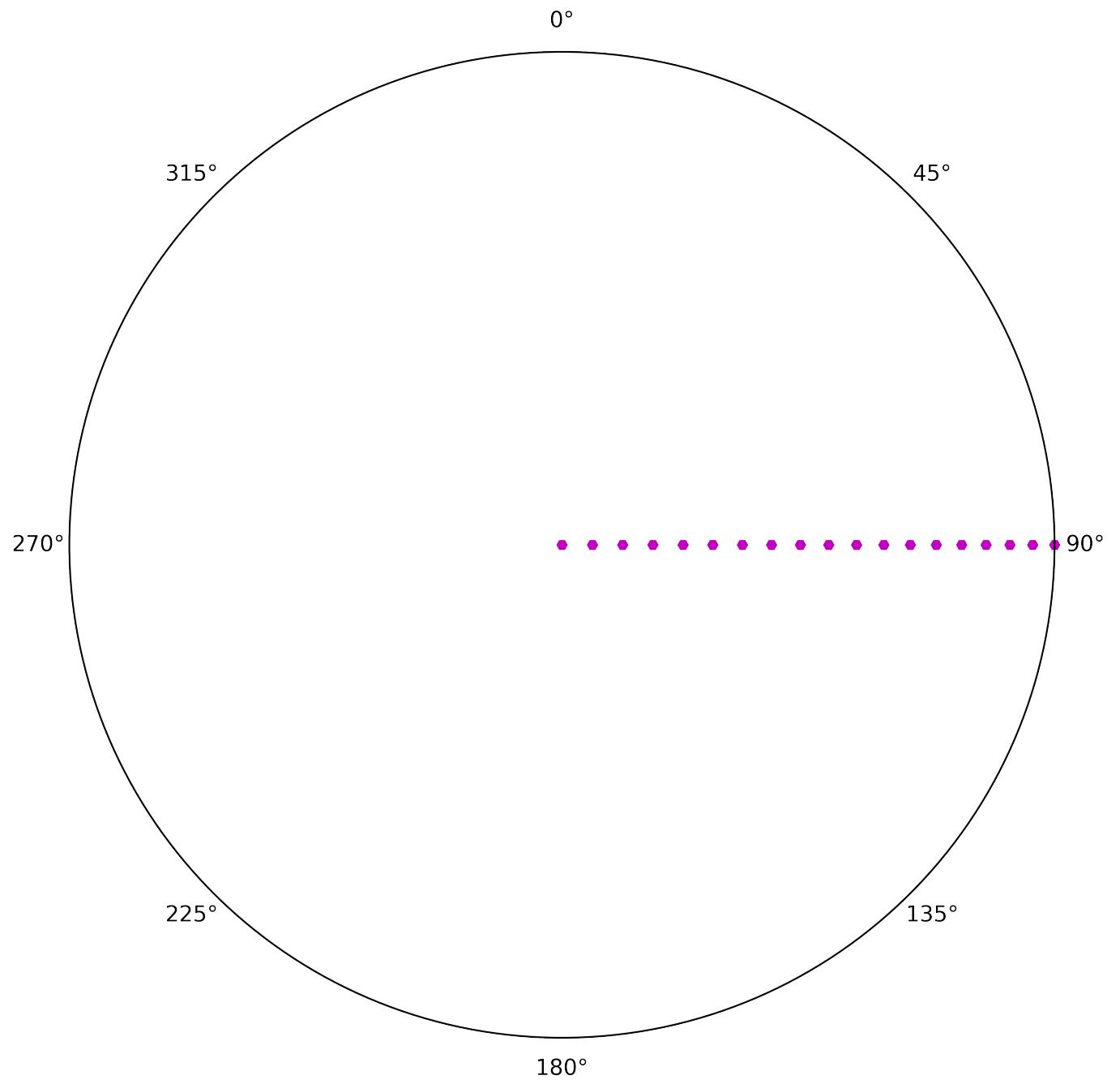


Figure 6: Sample Caption

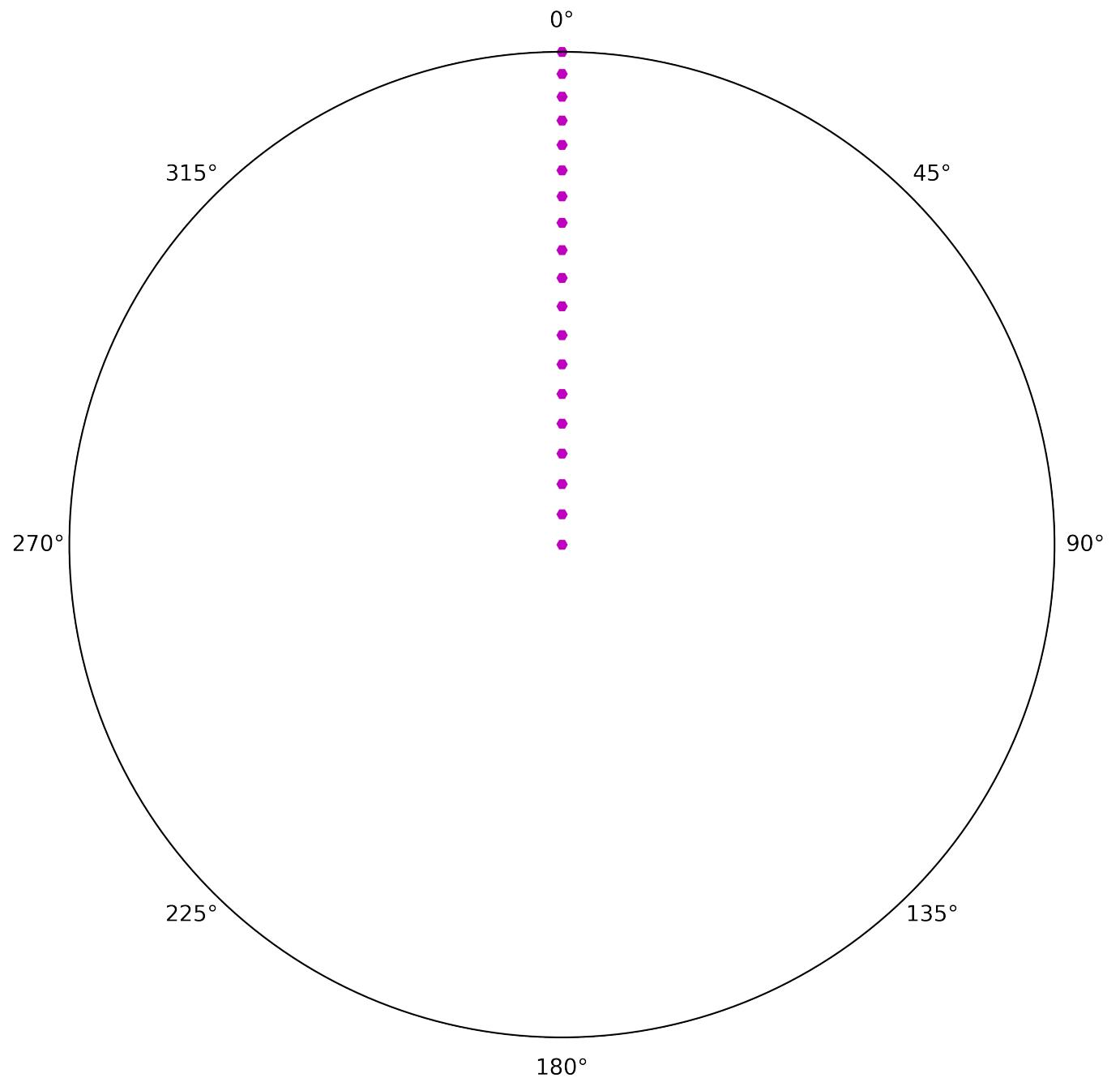


Figure 7: Sample Caption

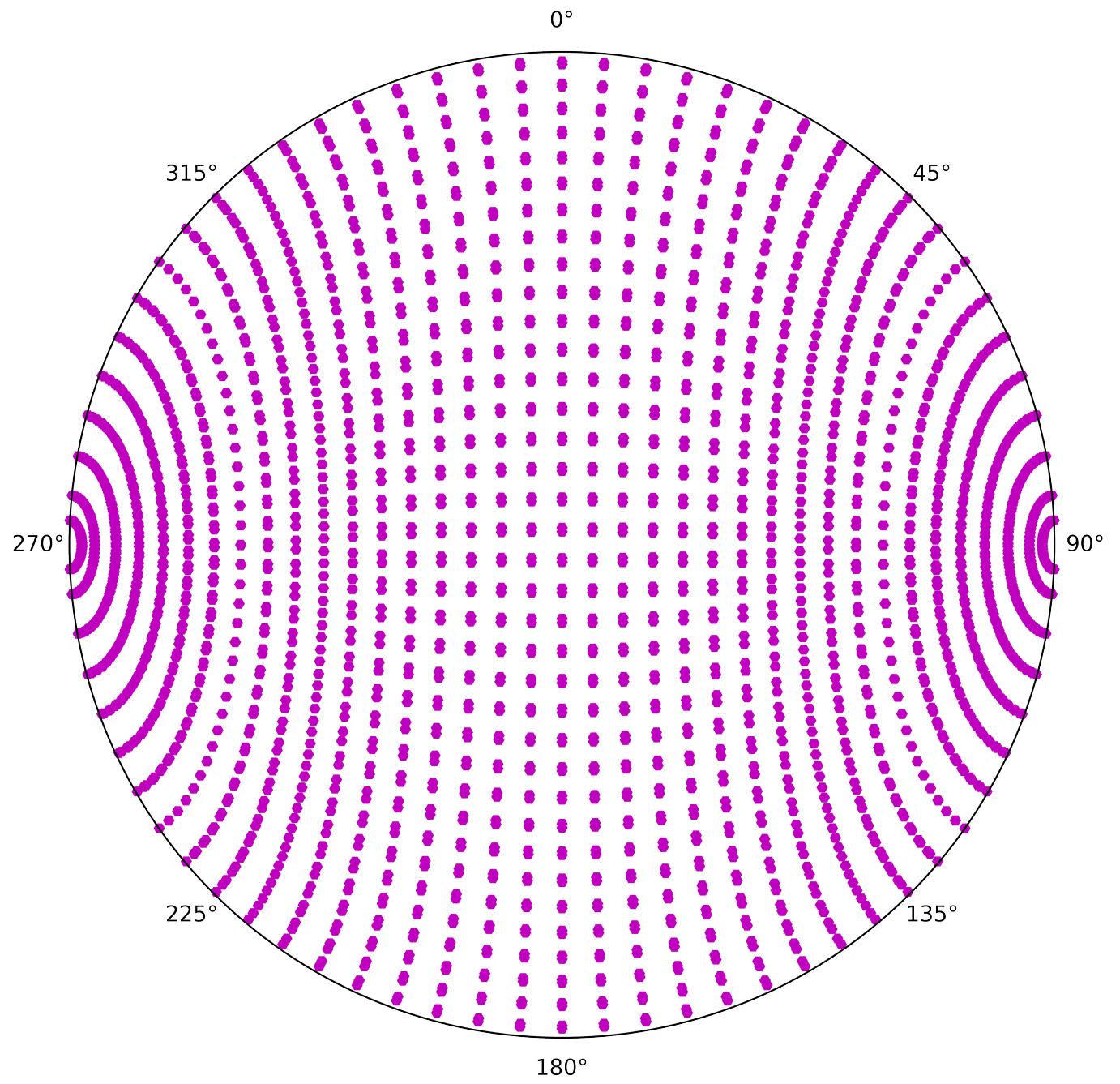


Figure 8: Sample Caption

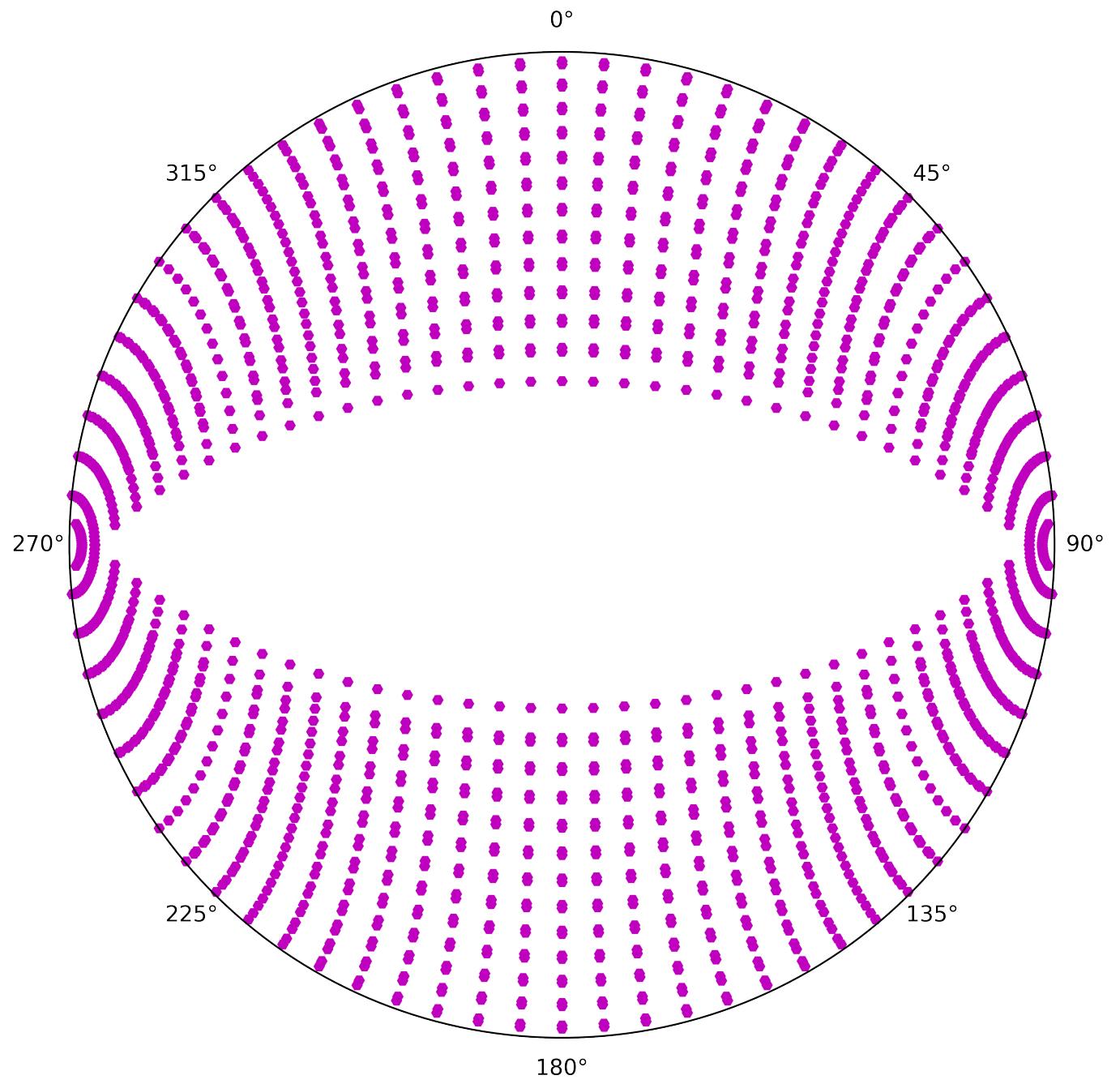


Figure 9: Sample Caption

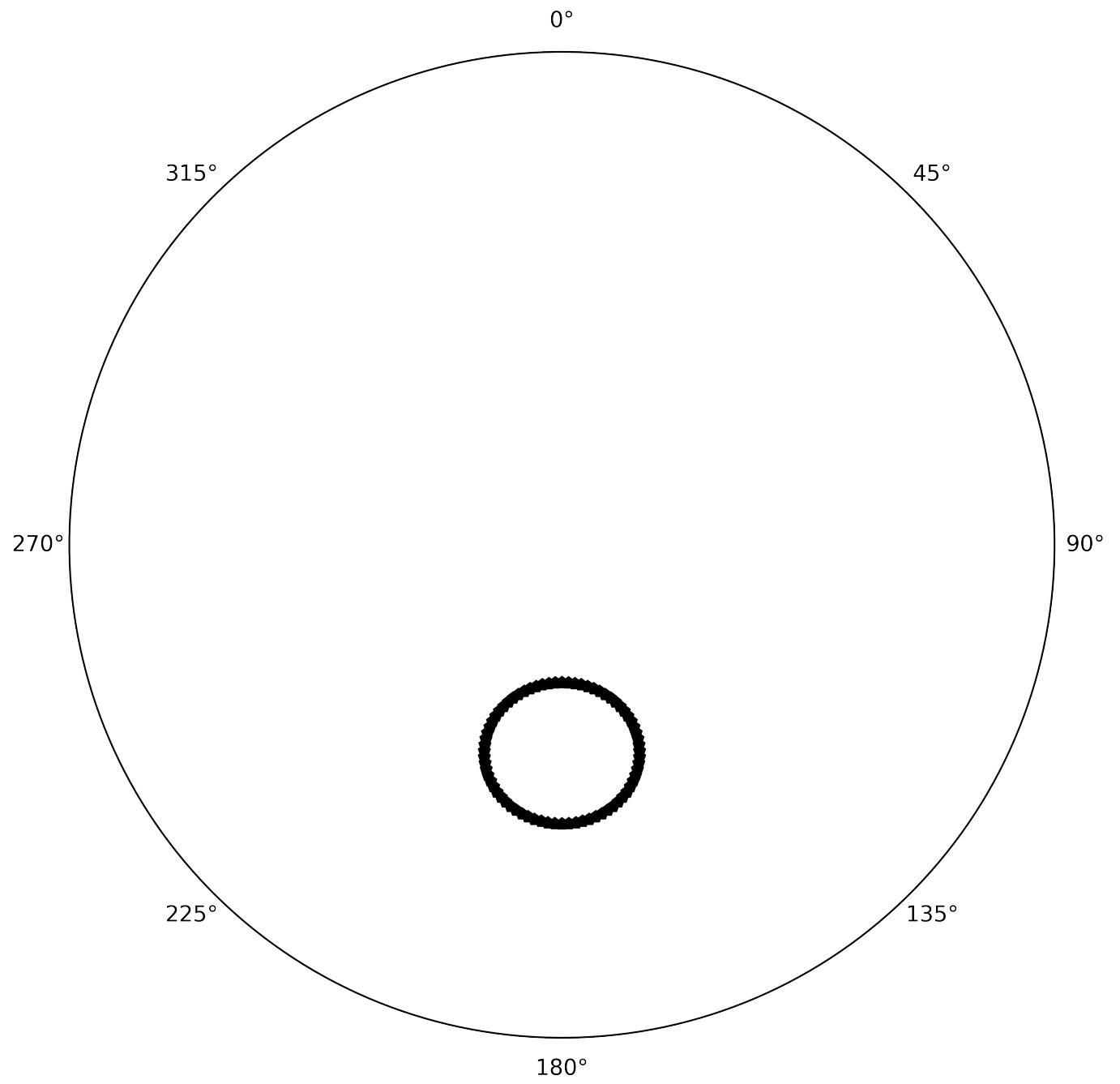


Figure 10: Sample Caption

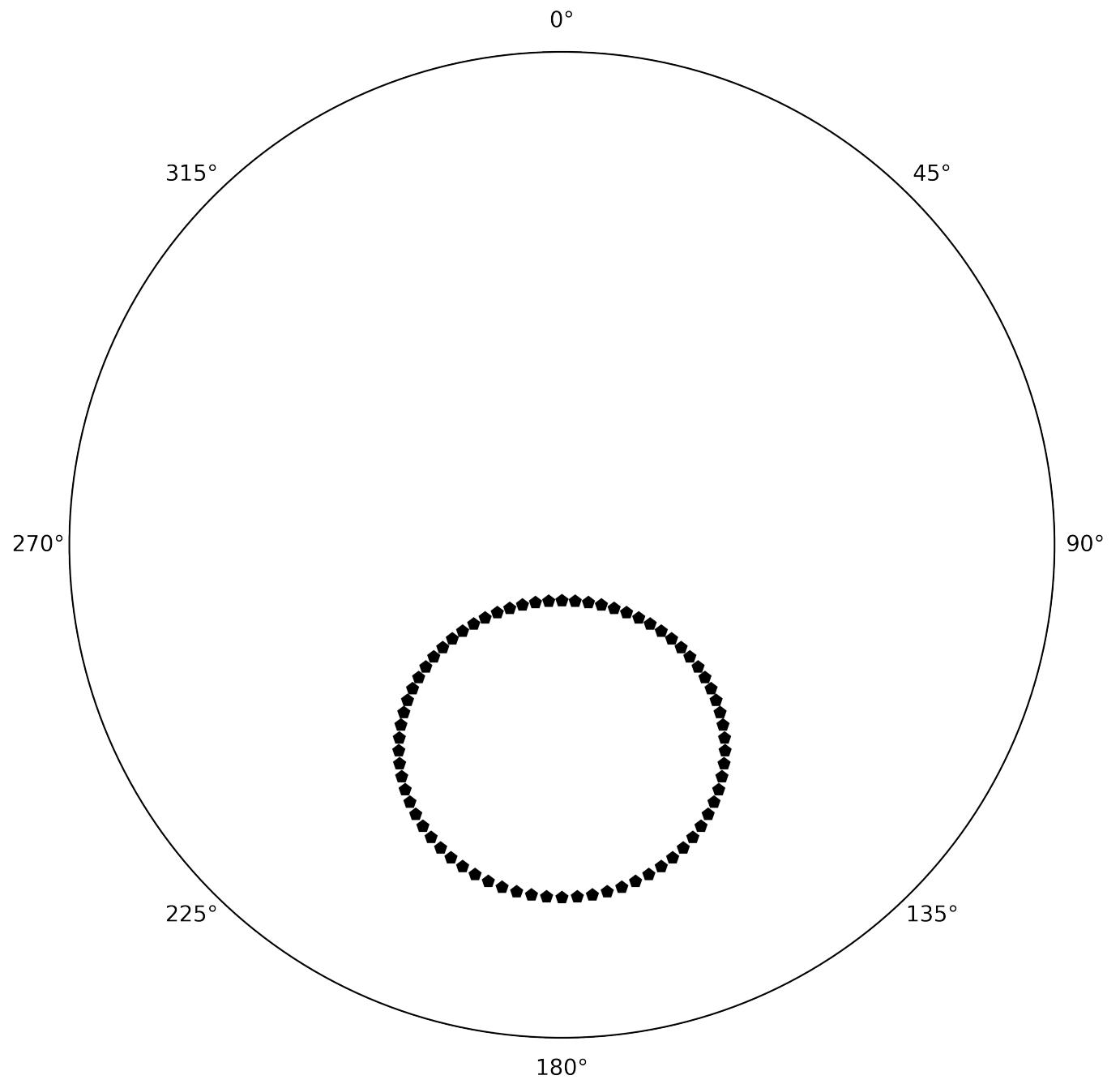


Figure 11: Sample Caption

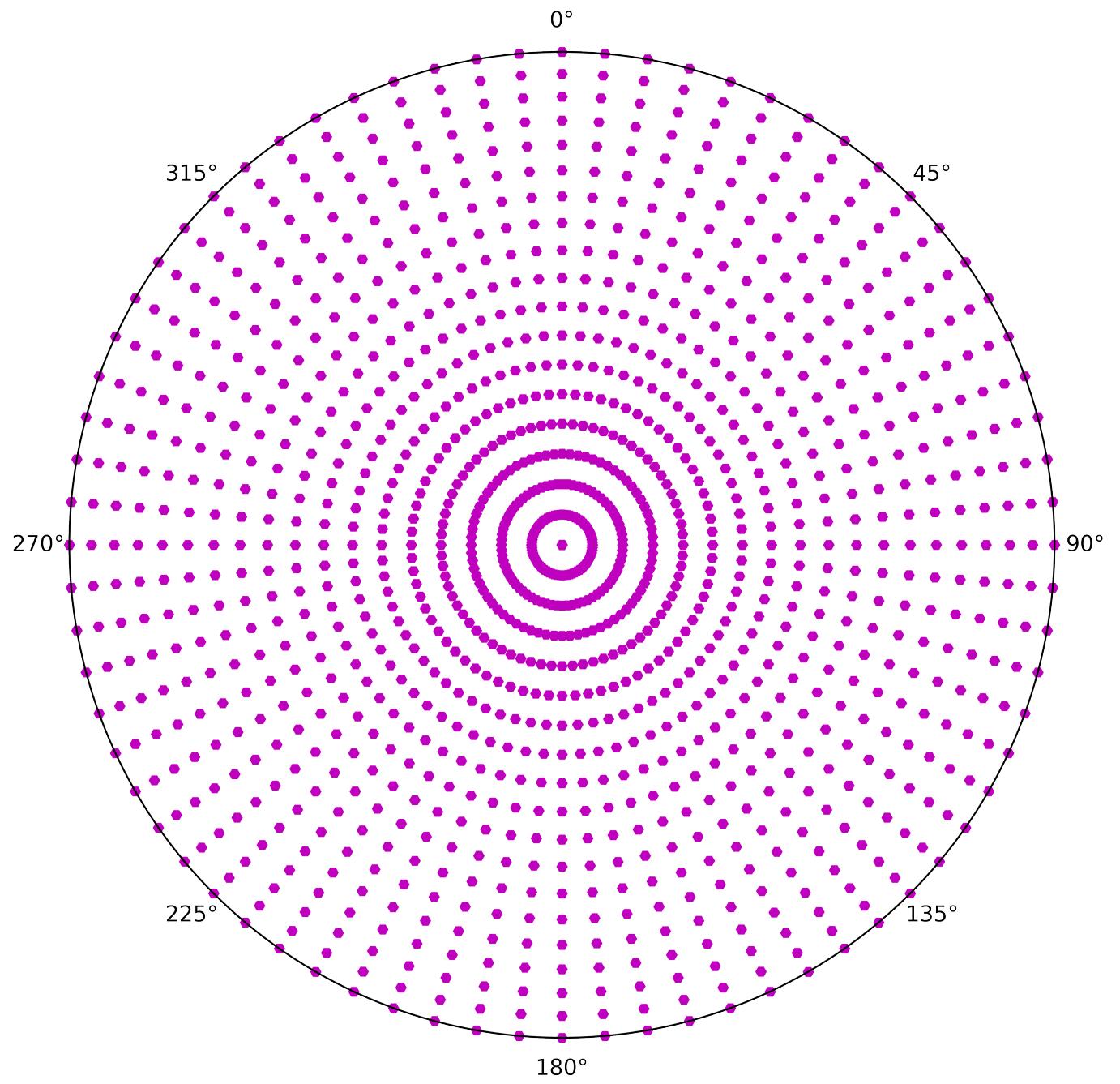


Figure 12: Sample Caption

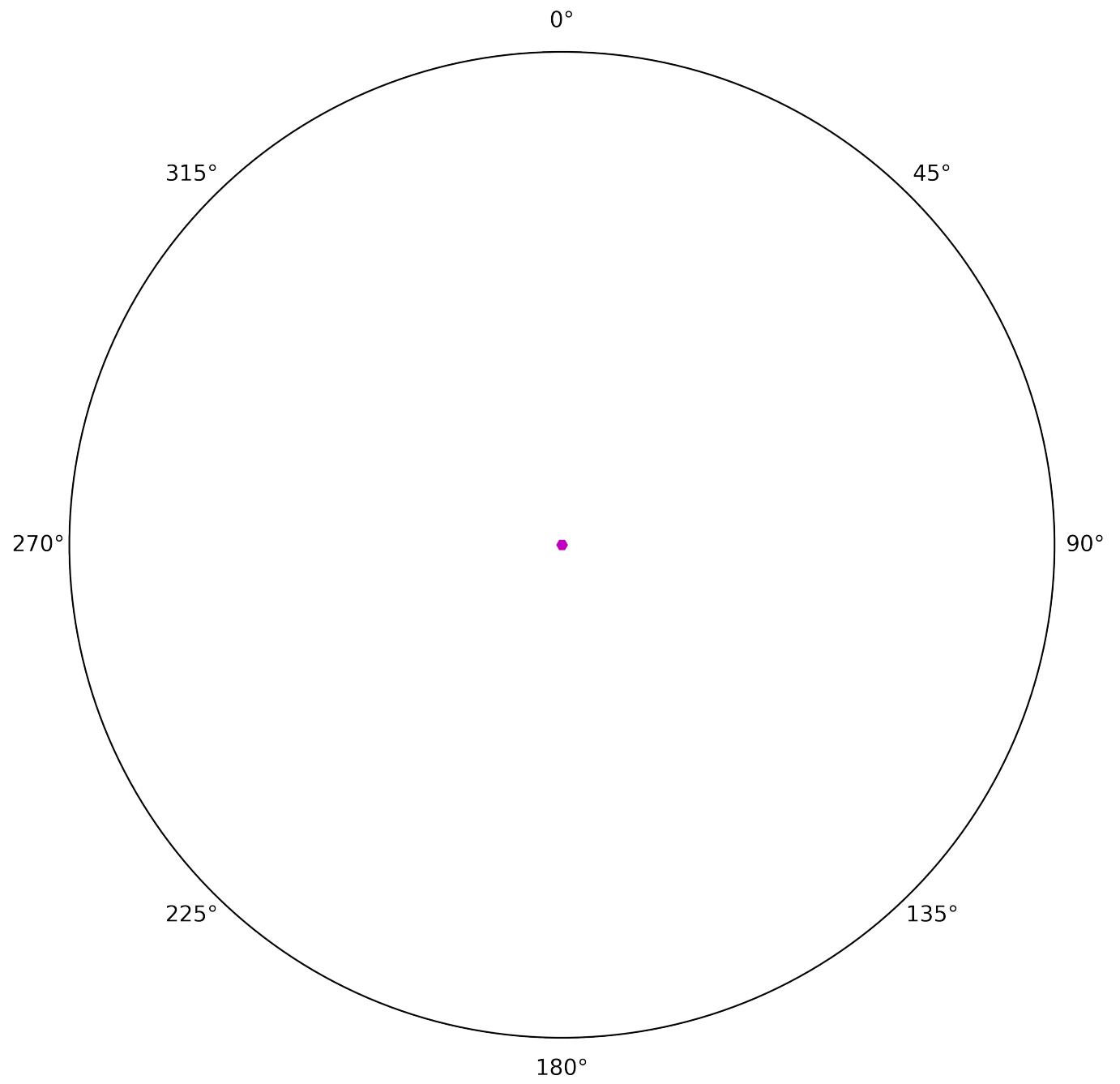


Figure 13: Sample Caption

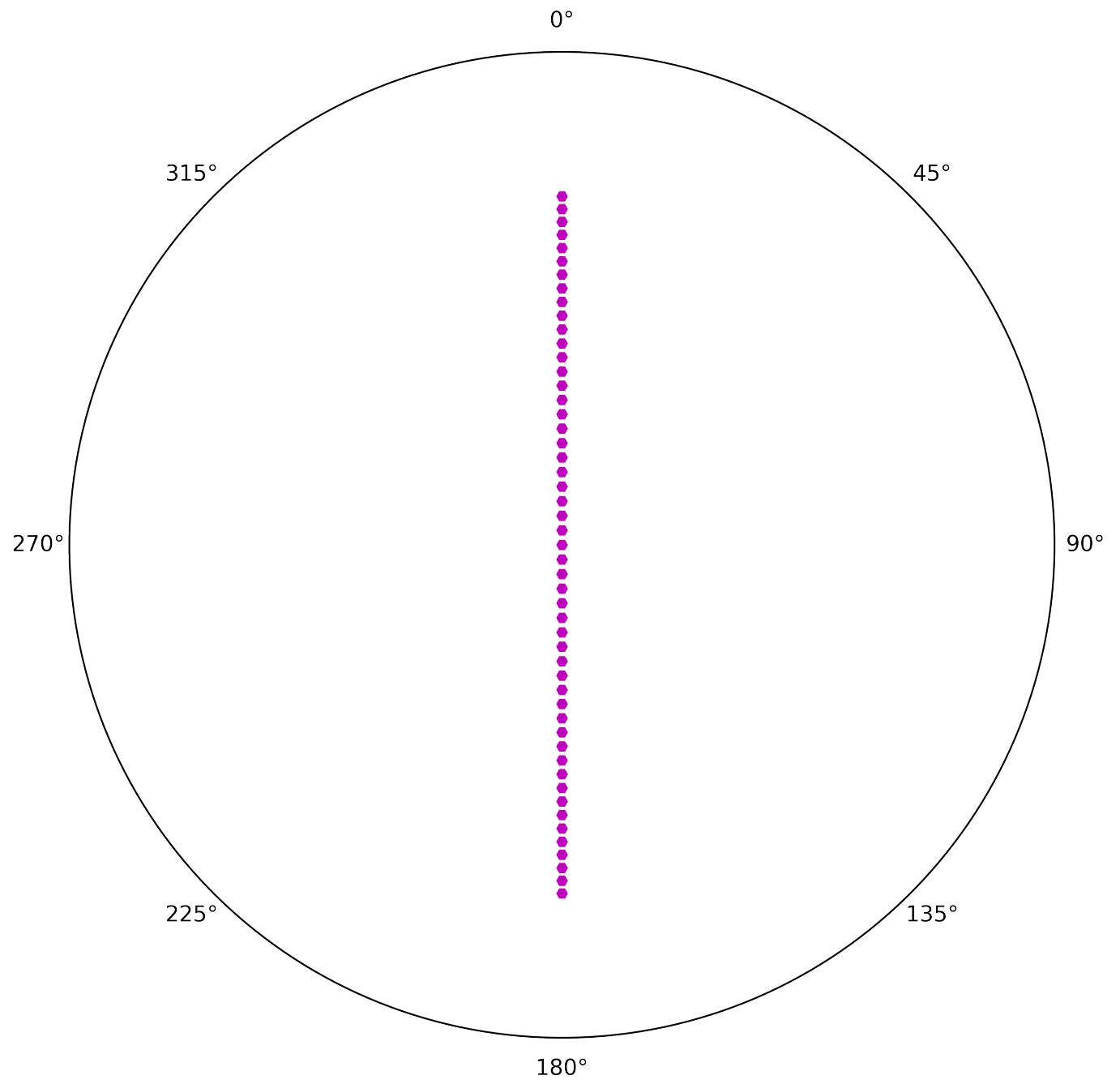


Figure 14: Sample Caption

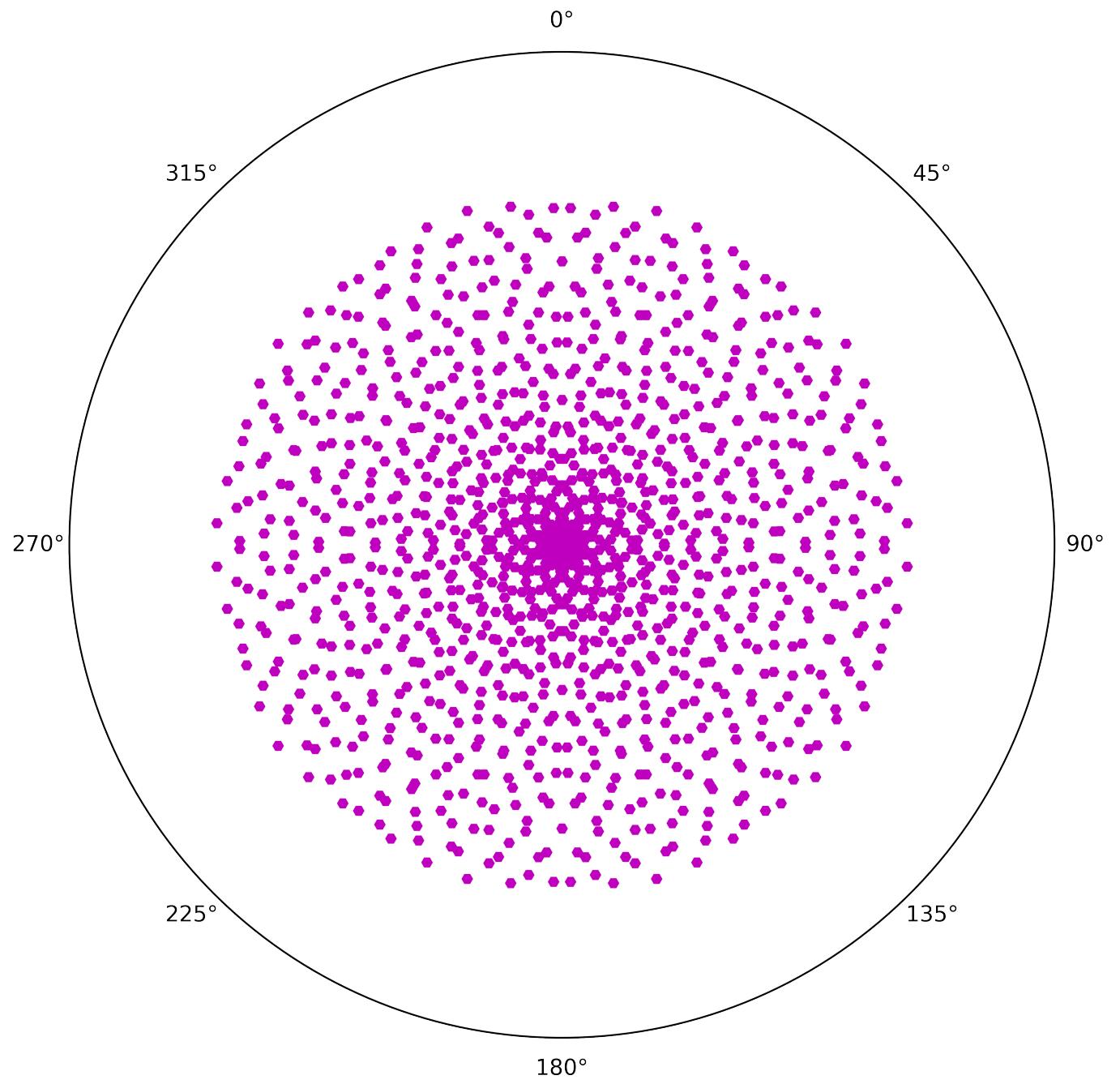


Figure 15: Sample Caption

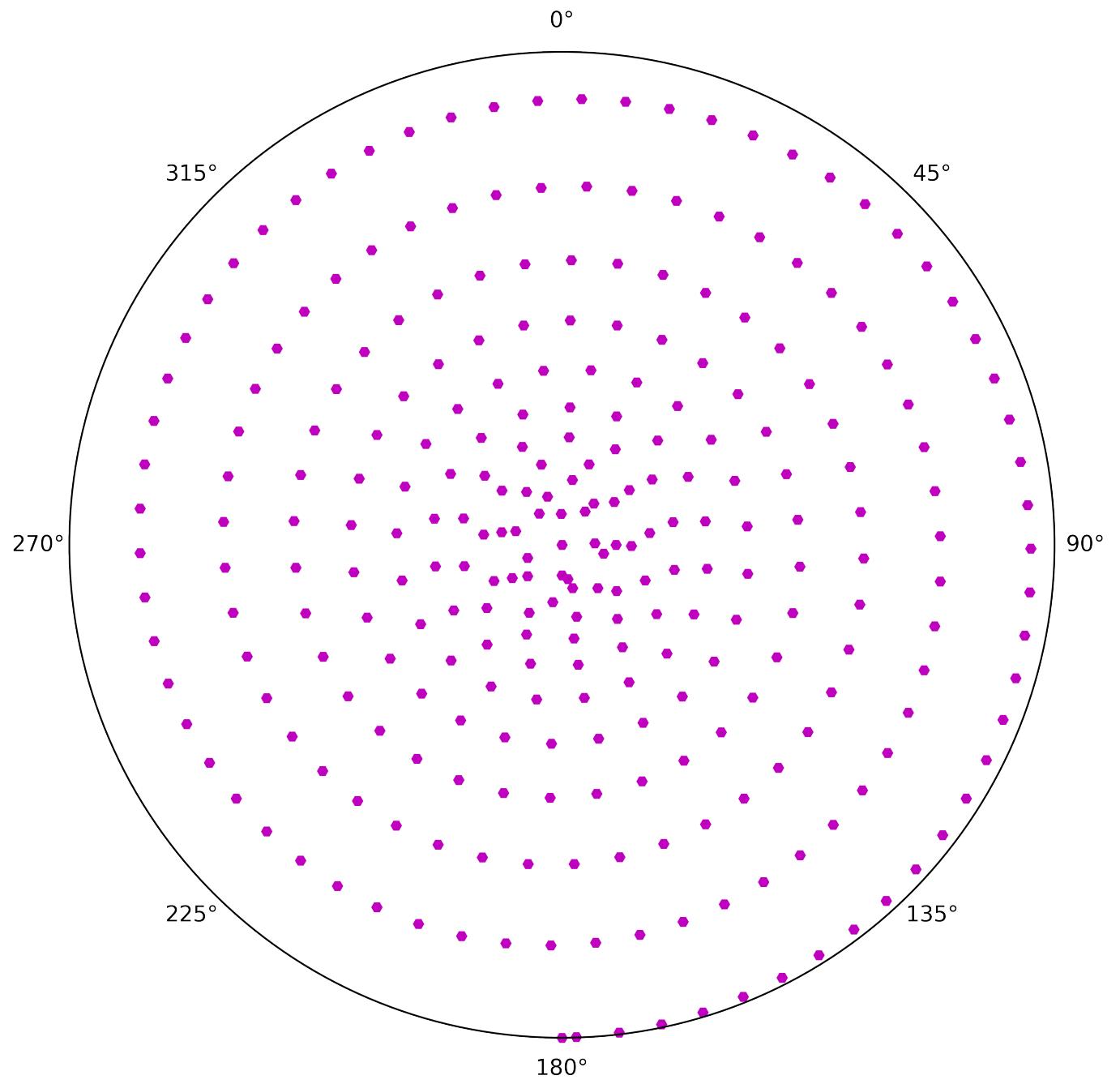


Figure 16: Sample Caption

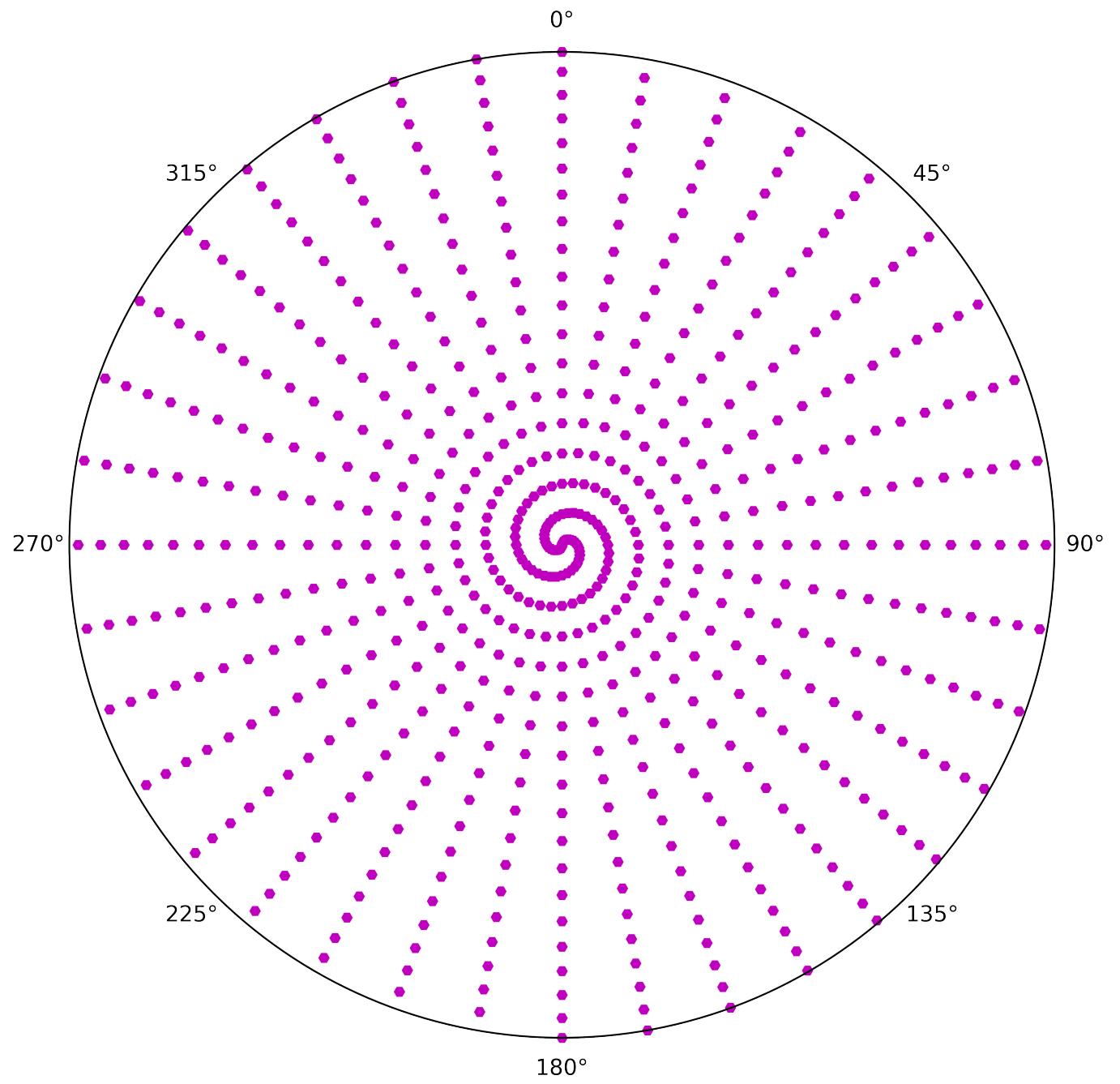


Figure 17: Sample Caption

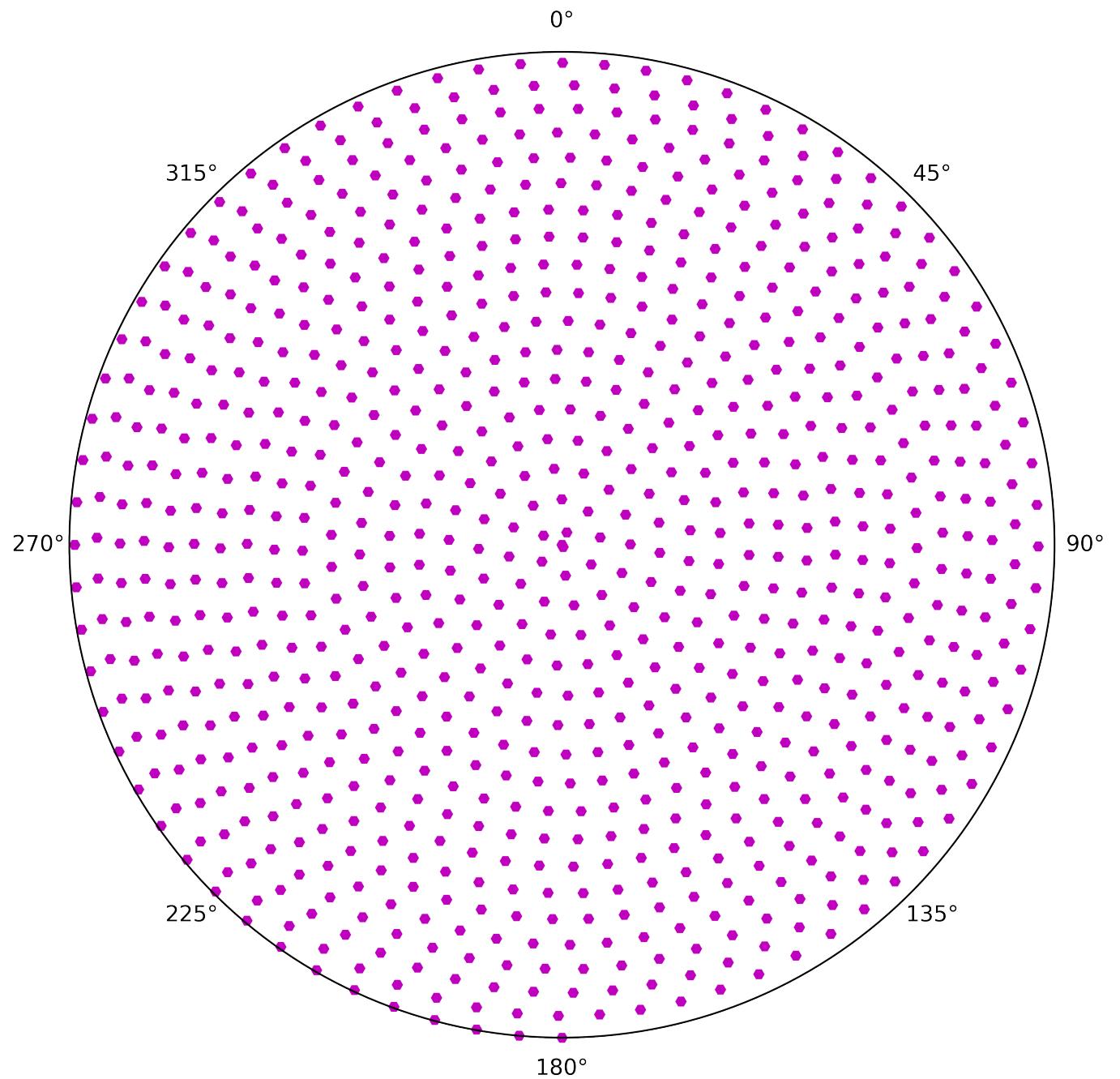


Figure 18: Sample Caption

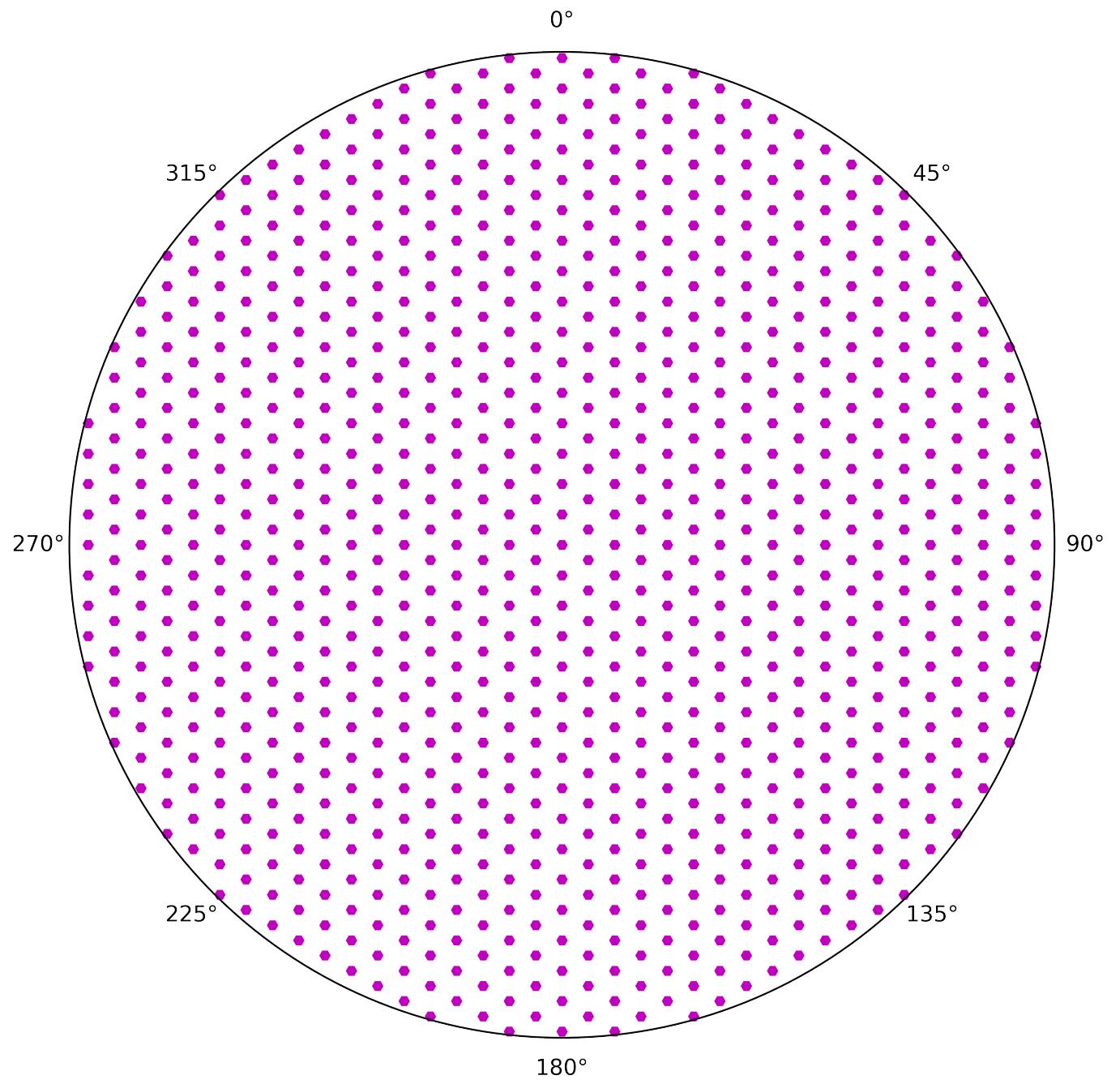


Figure 19: Sample Caption

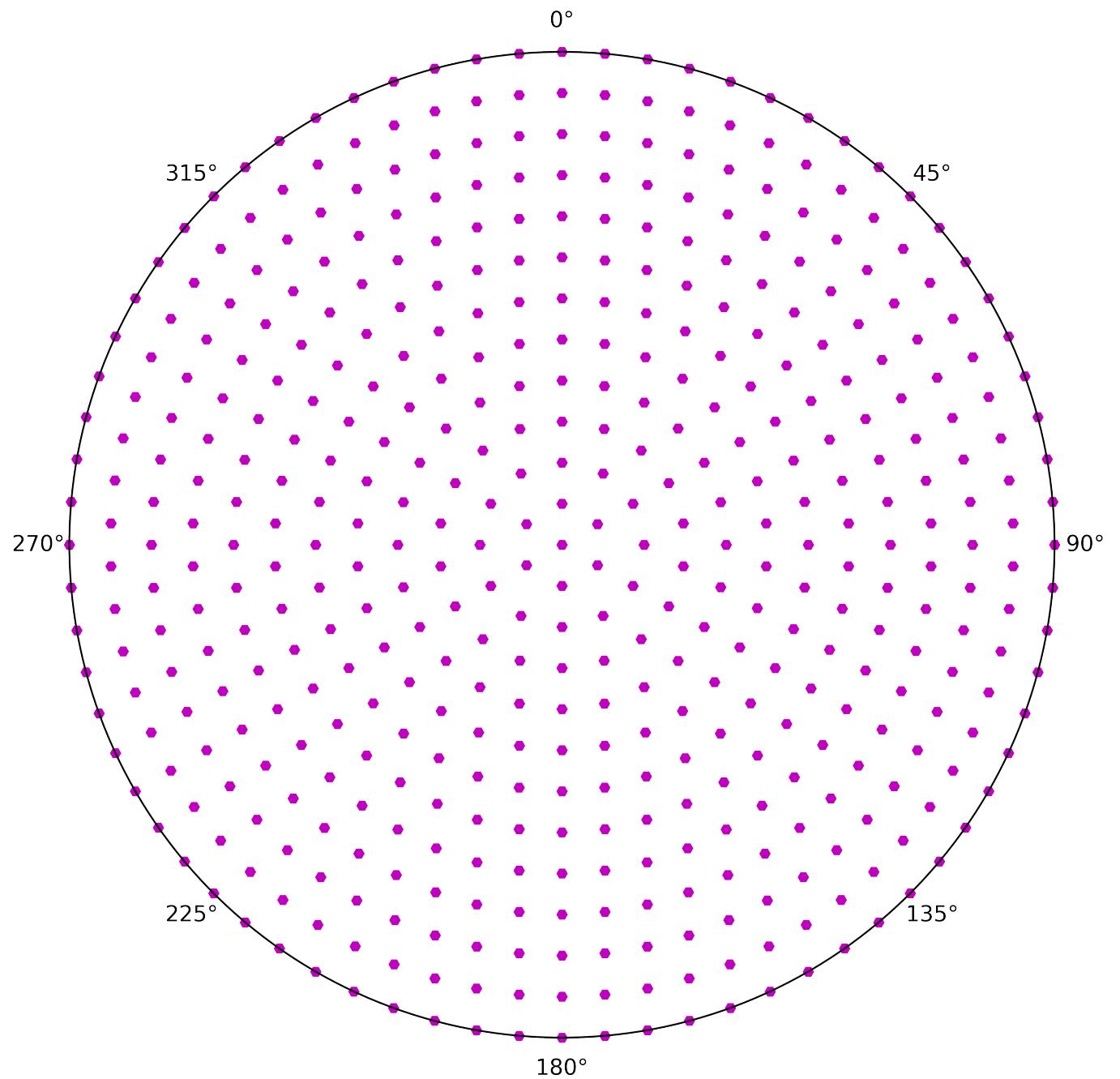


Figure 20: Sample Caption

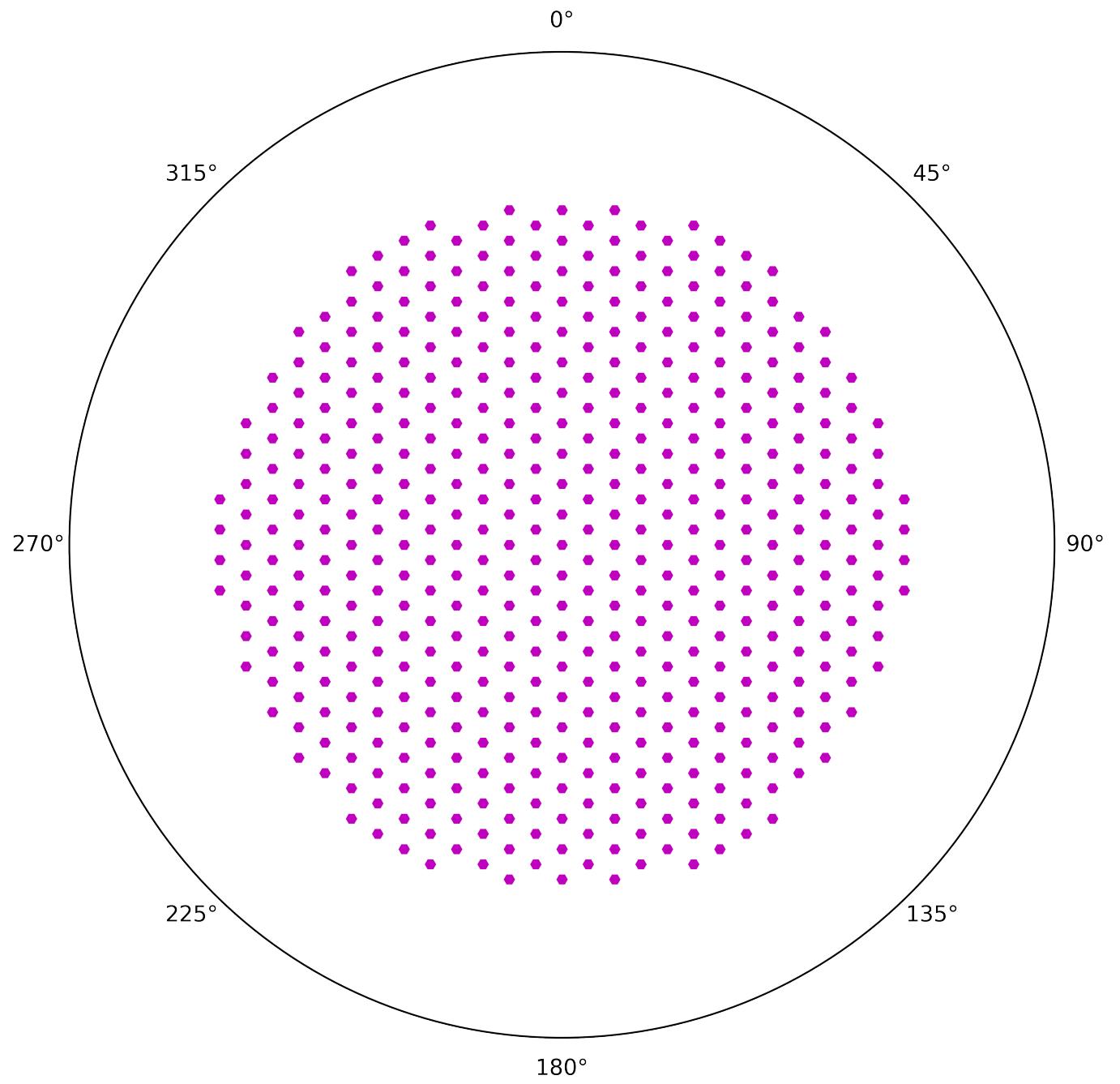


Figure 21: Sample Caption

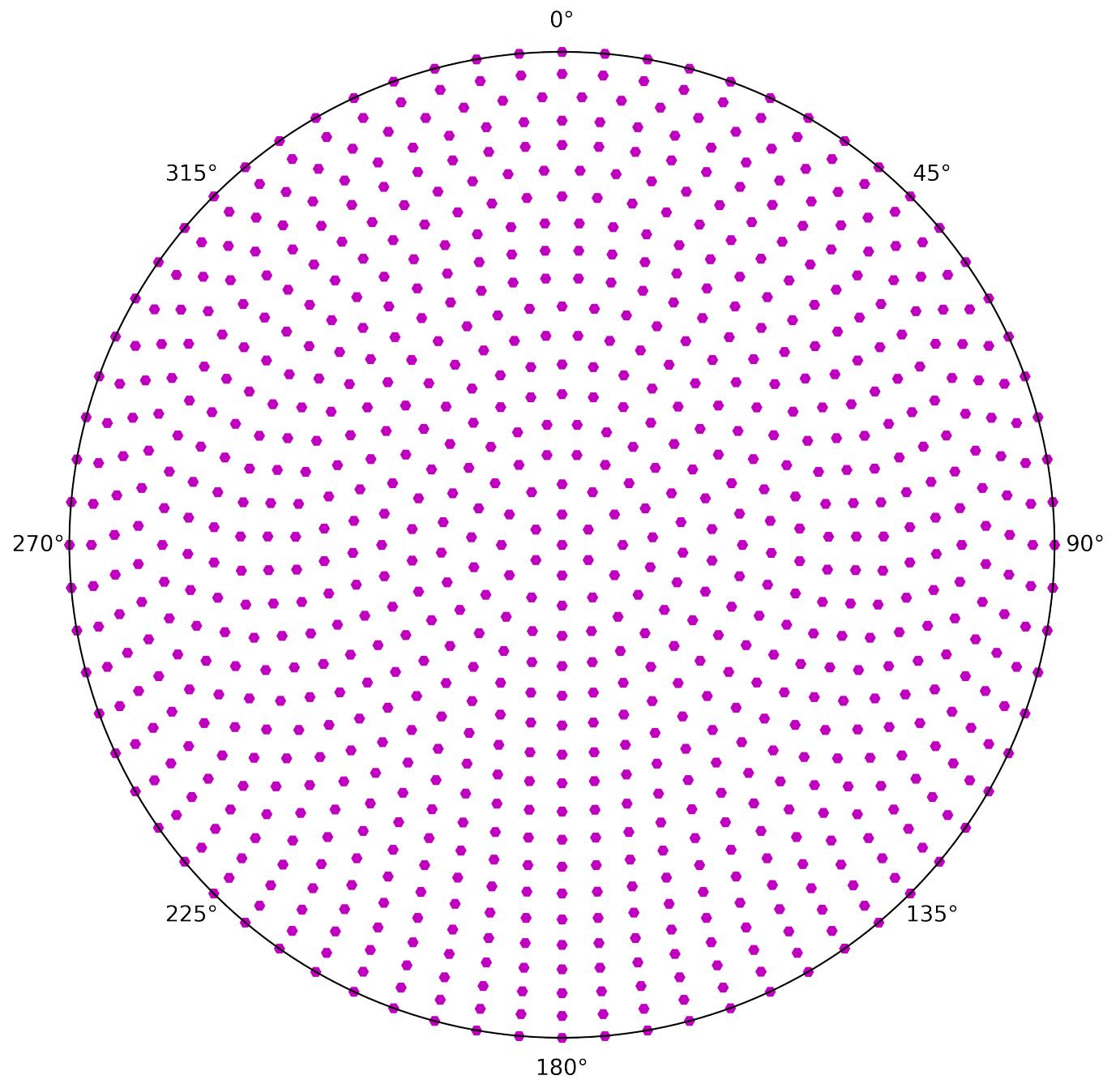


Figure 22: Sample Caption

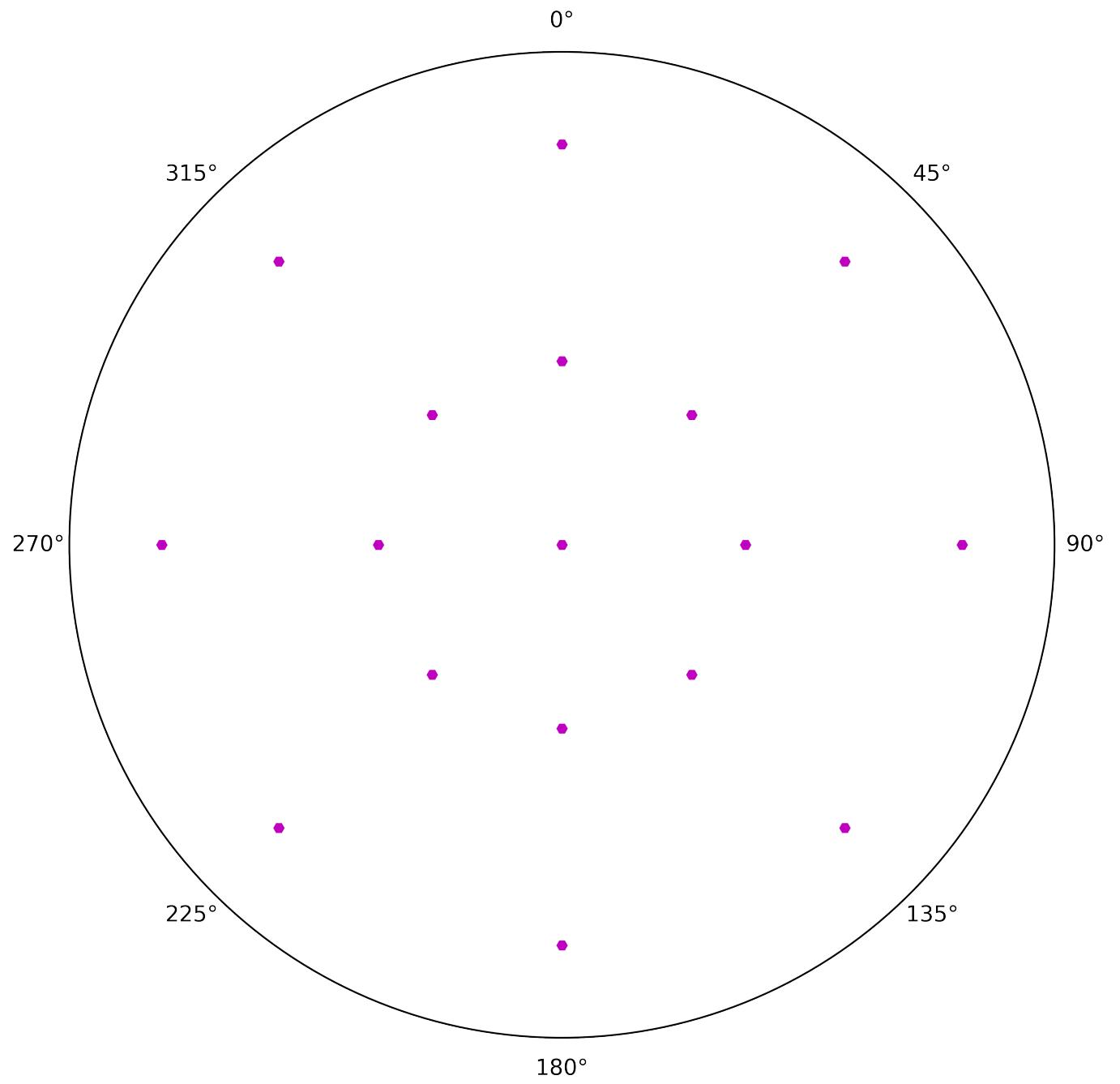


Figure 23: Sample Caption

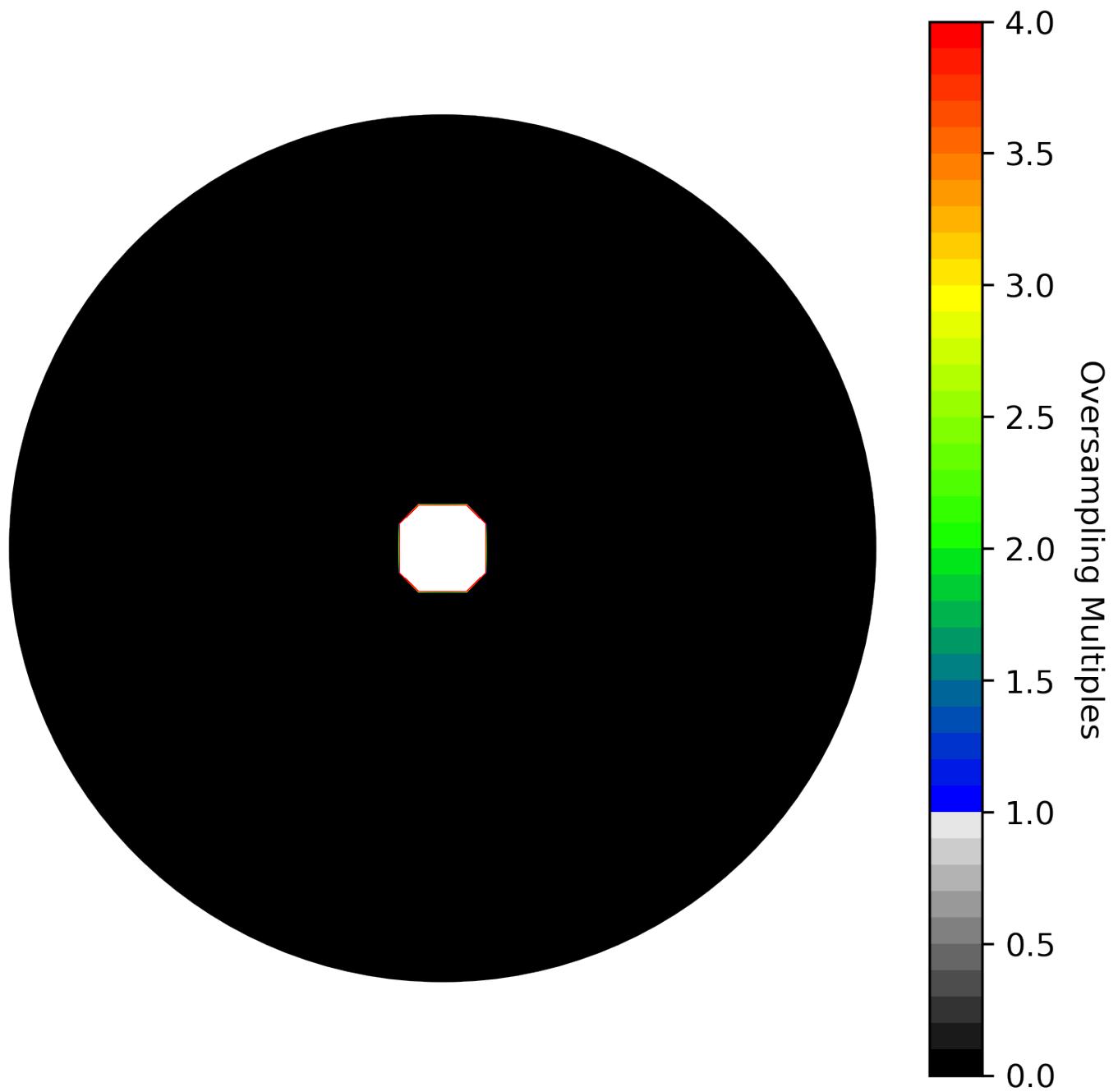


Figure 24: Sample Caption

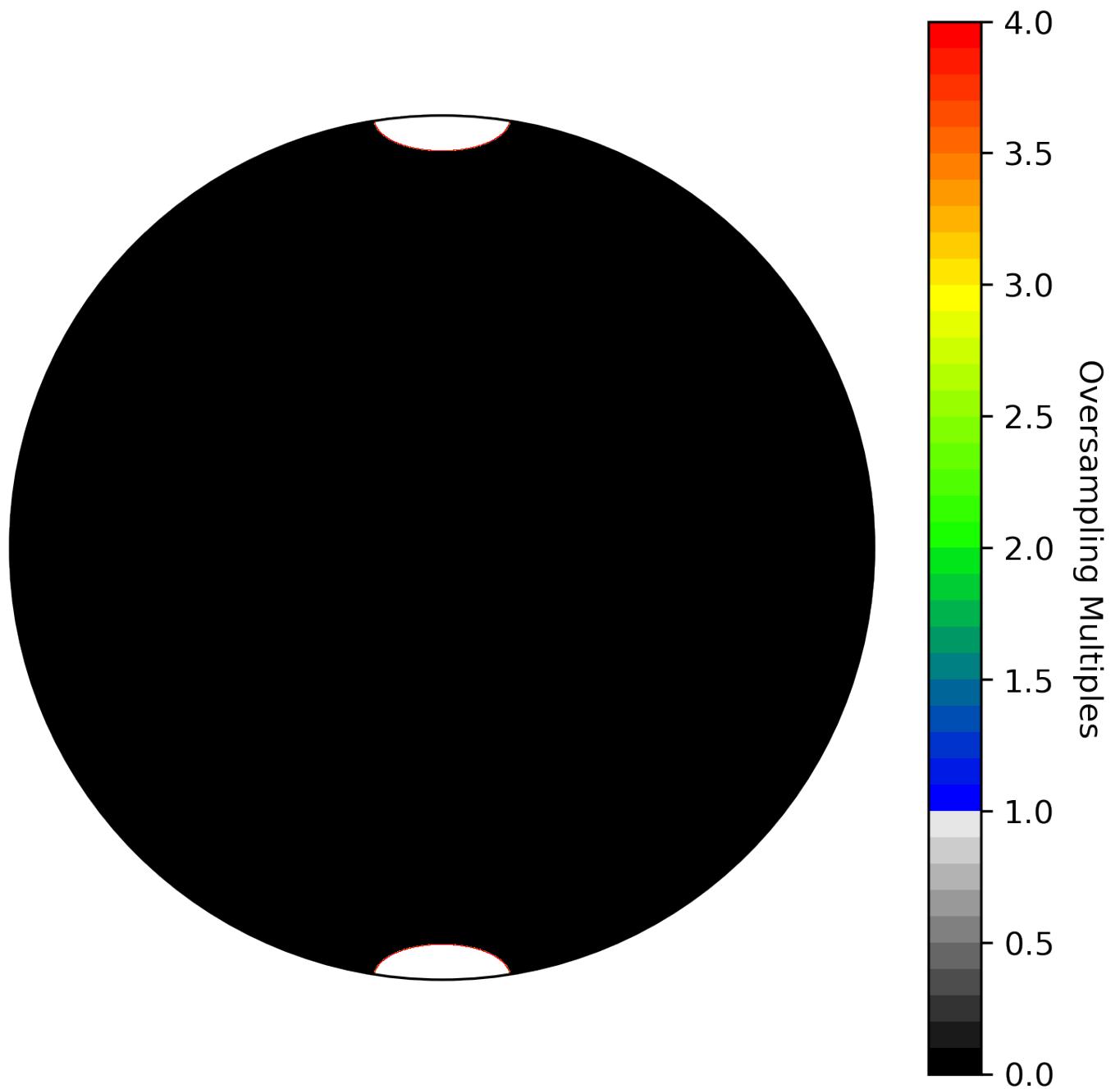


Figure 25: Sample Caption

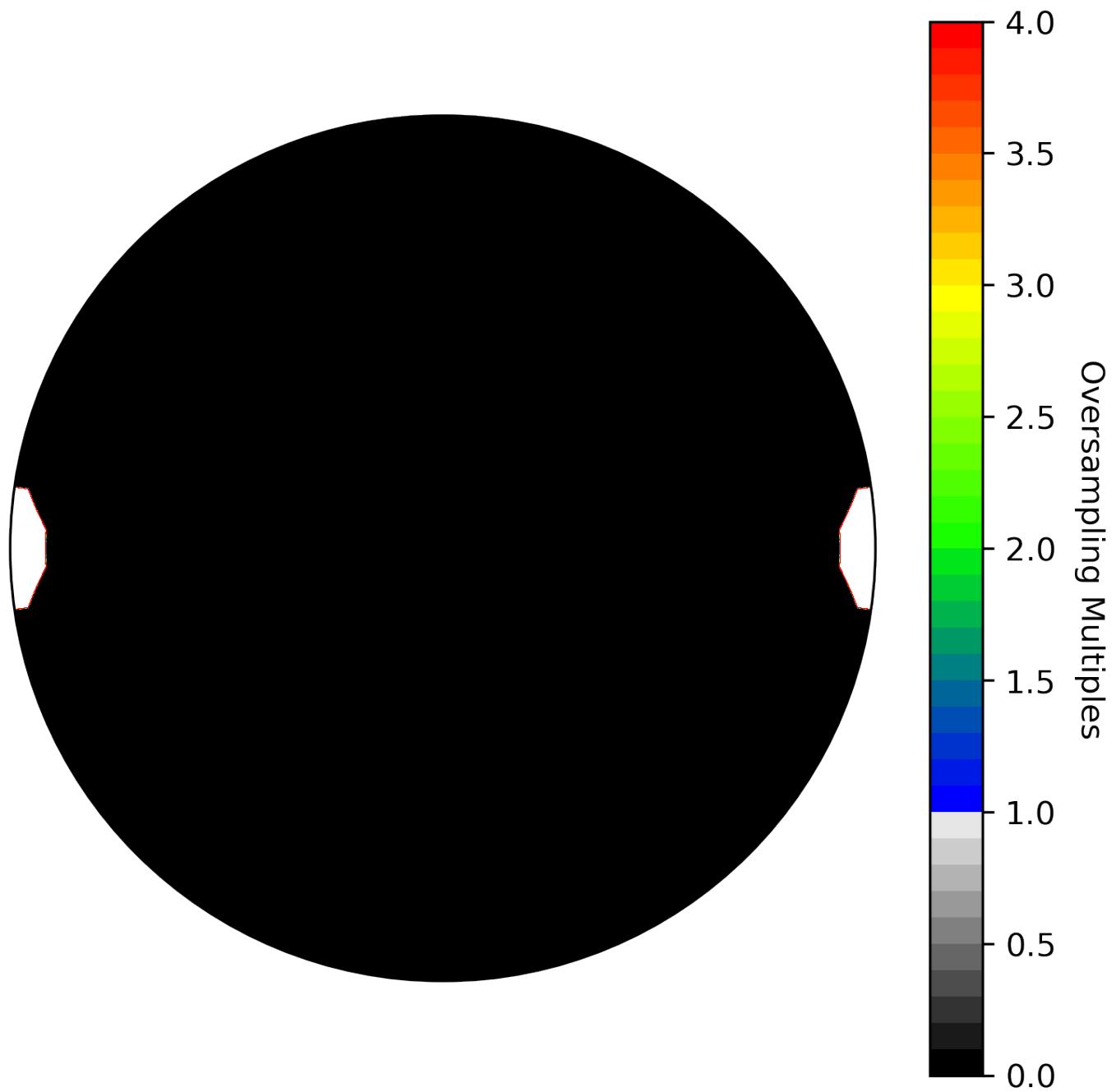


Figure 26: Sample Caption

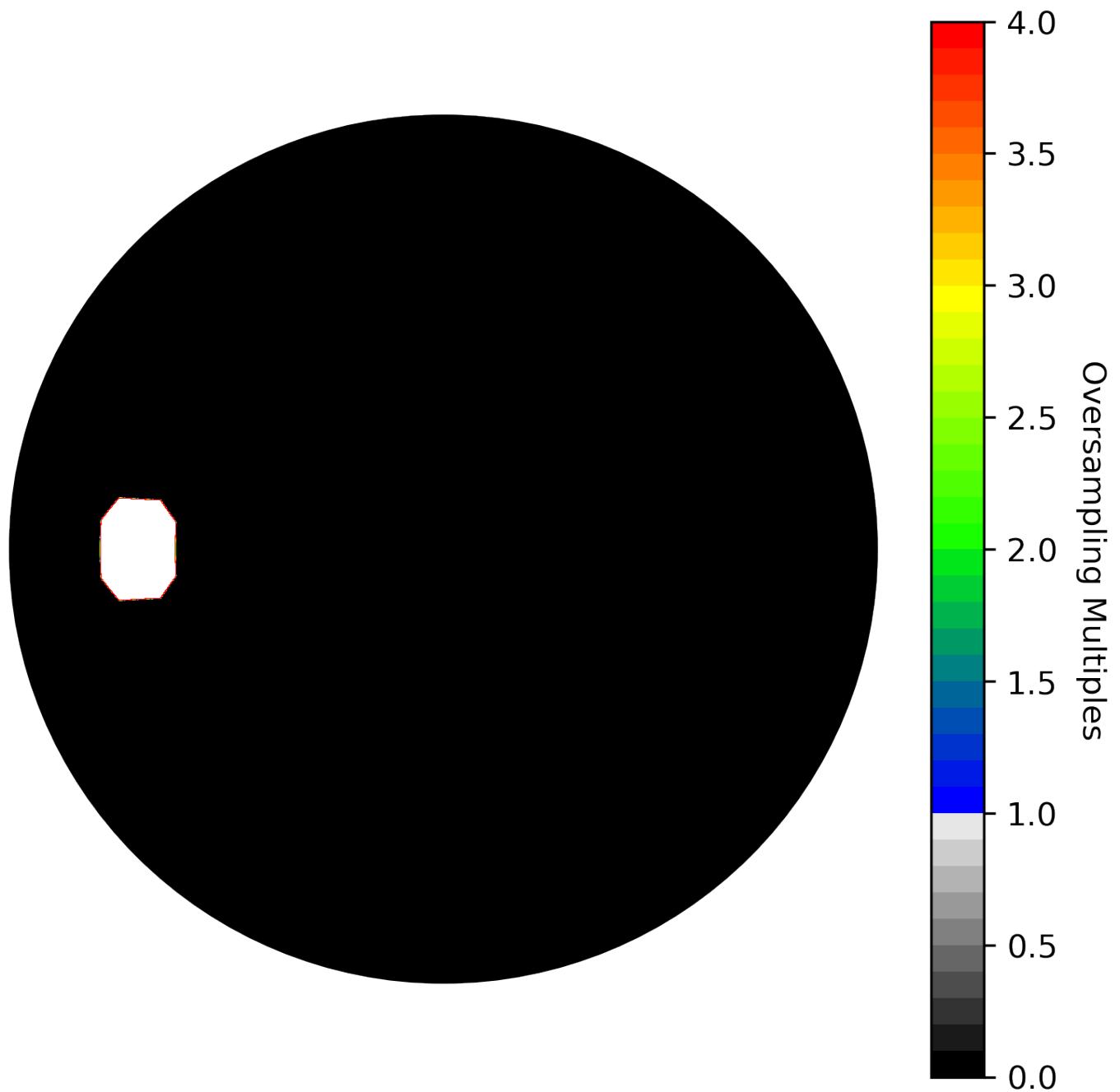


Figure 27: Sample Caption

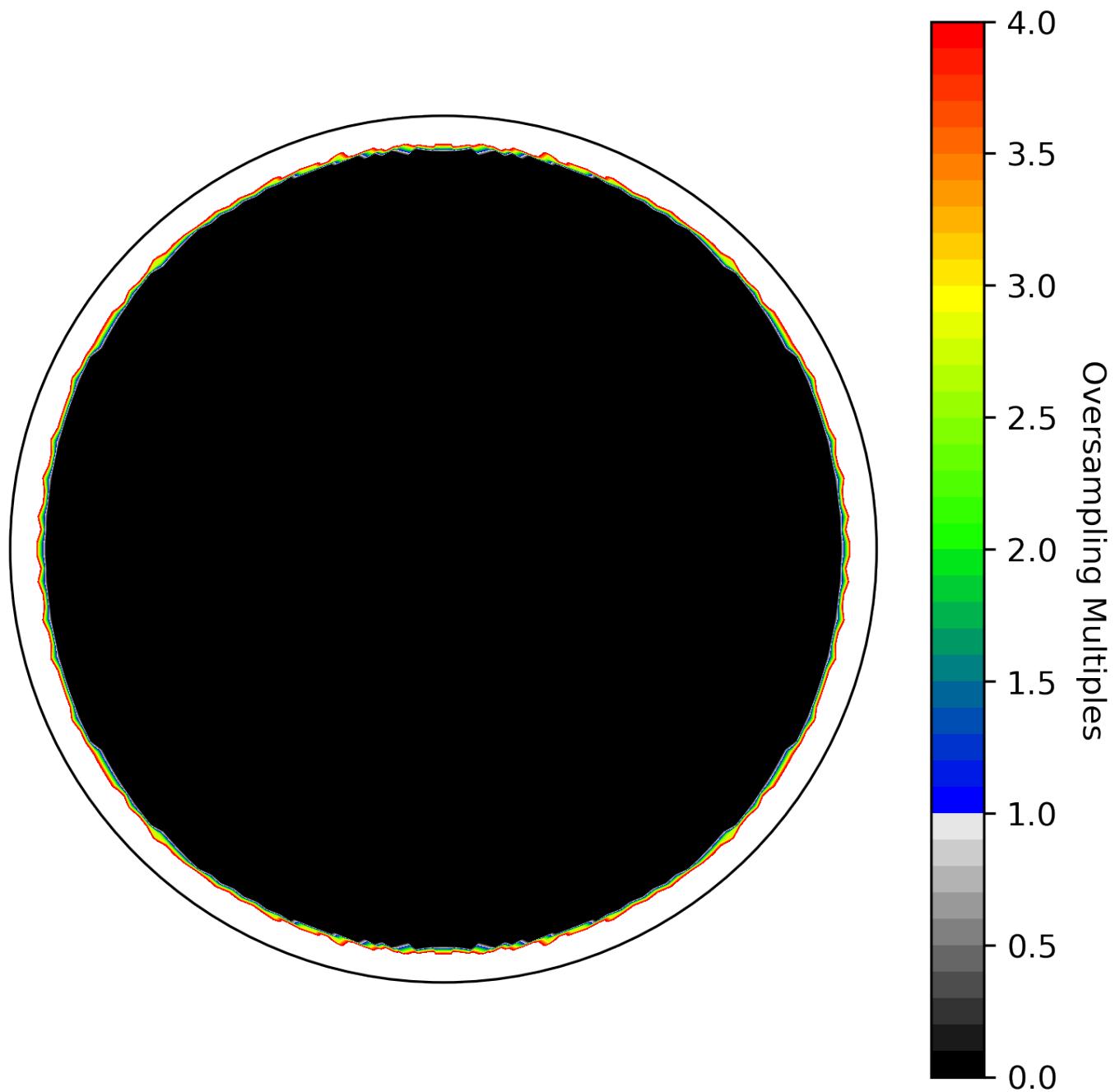


Figure 28: Sample Caption

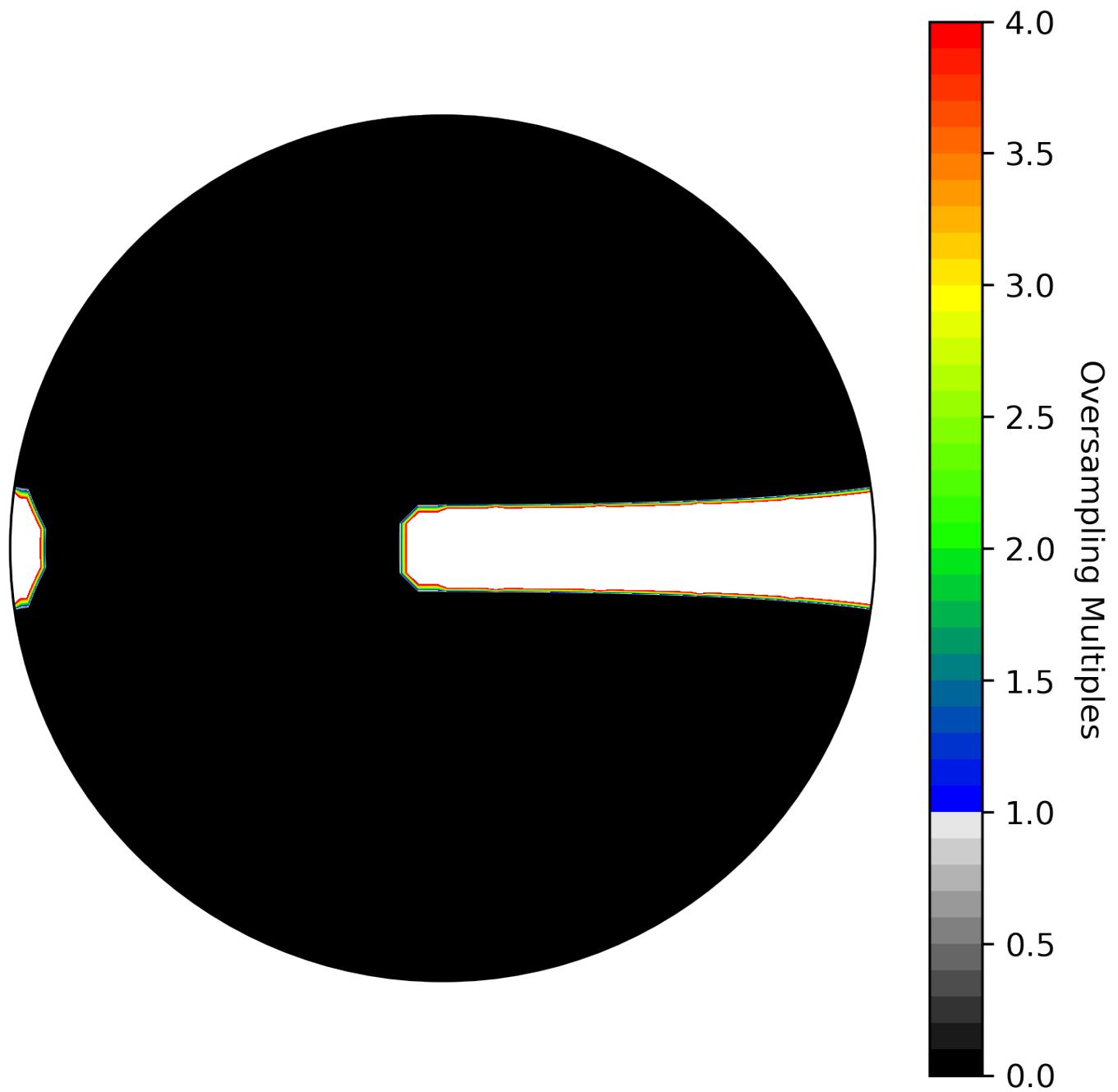


Figure 29: Sample Caption

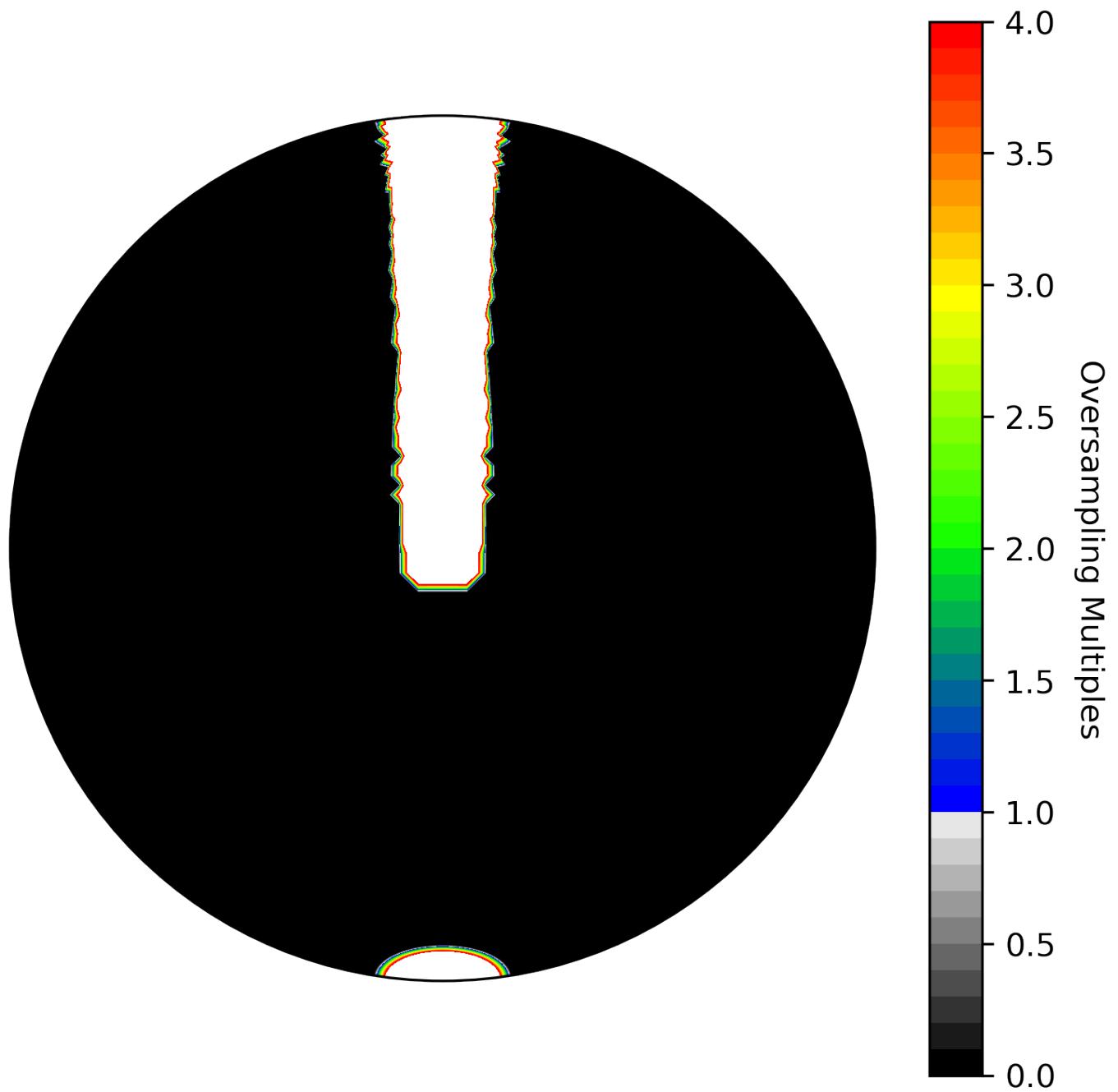


Figure 30: Sample Caption

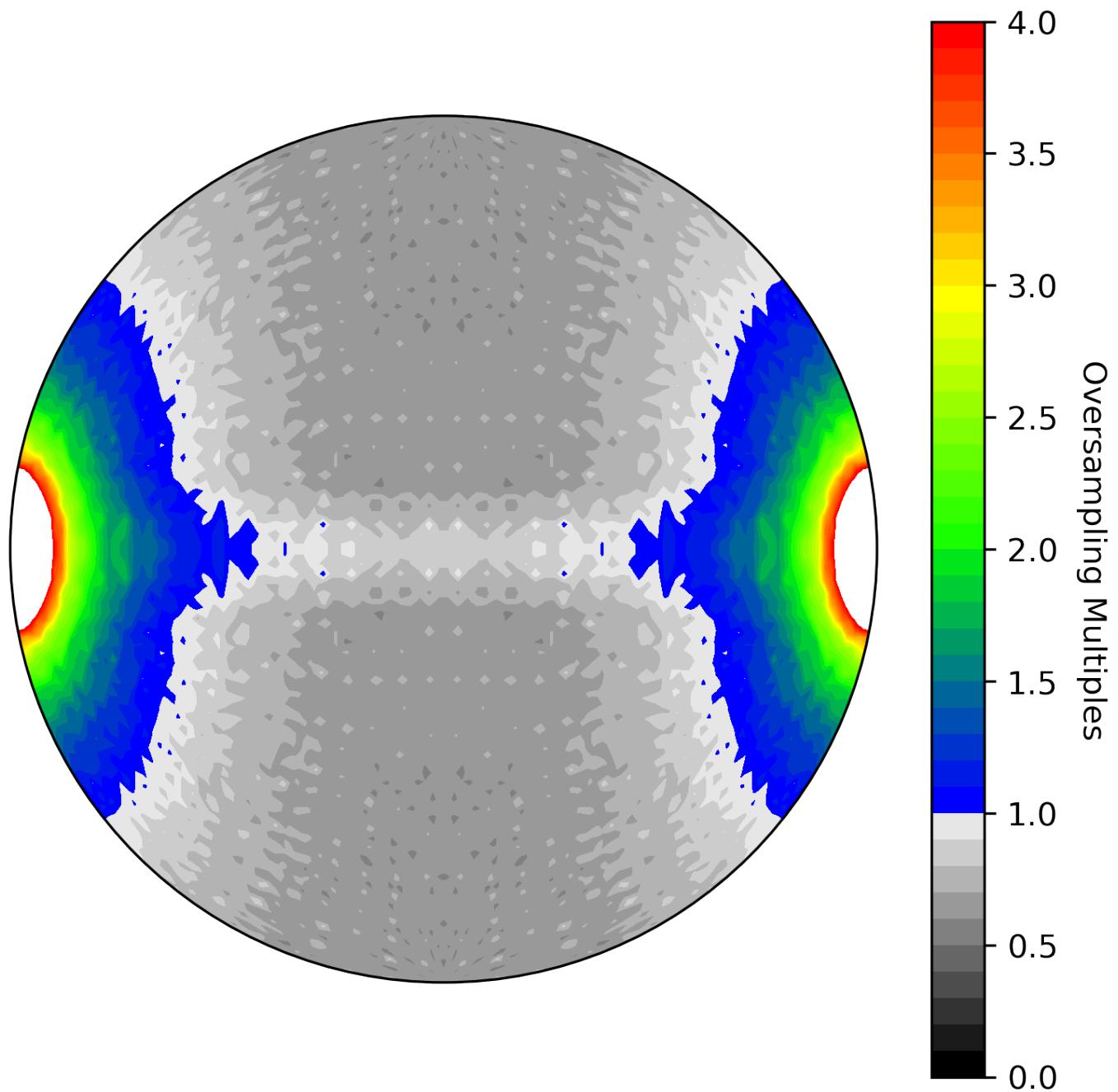


Figure 31: Sample Caption

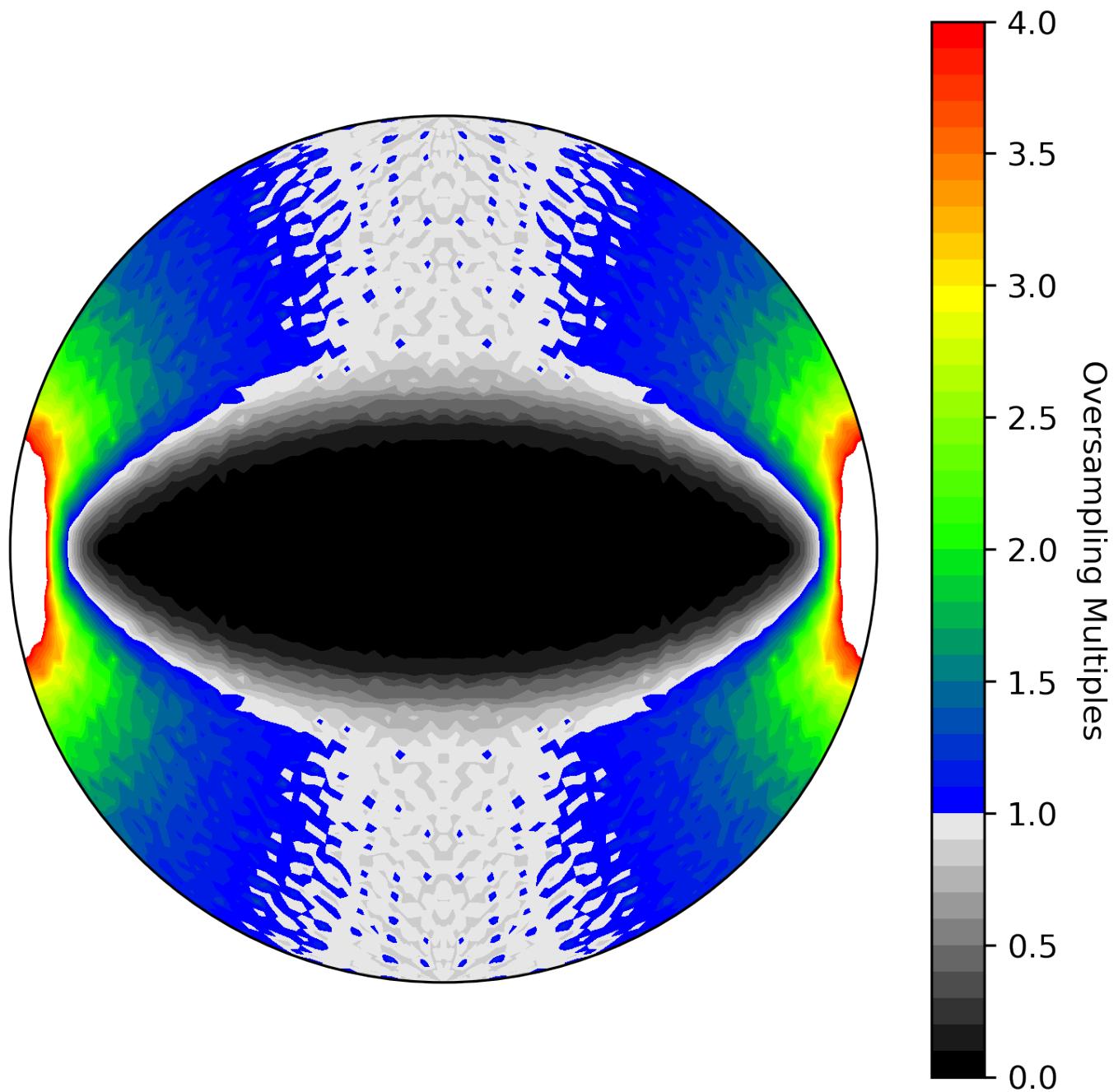


Figure 32: Sample Caption

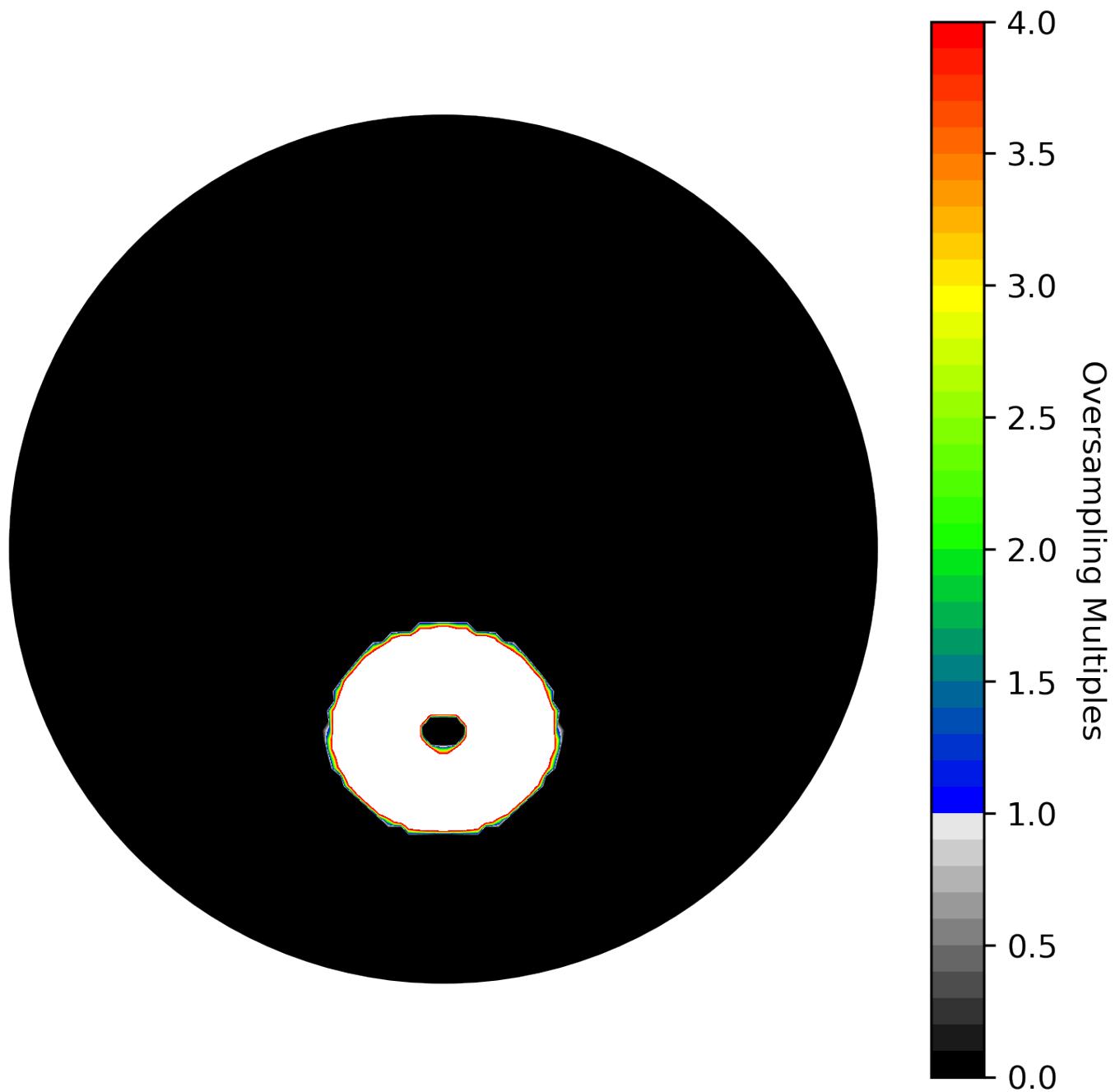


Figure 33: Sample Caption

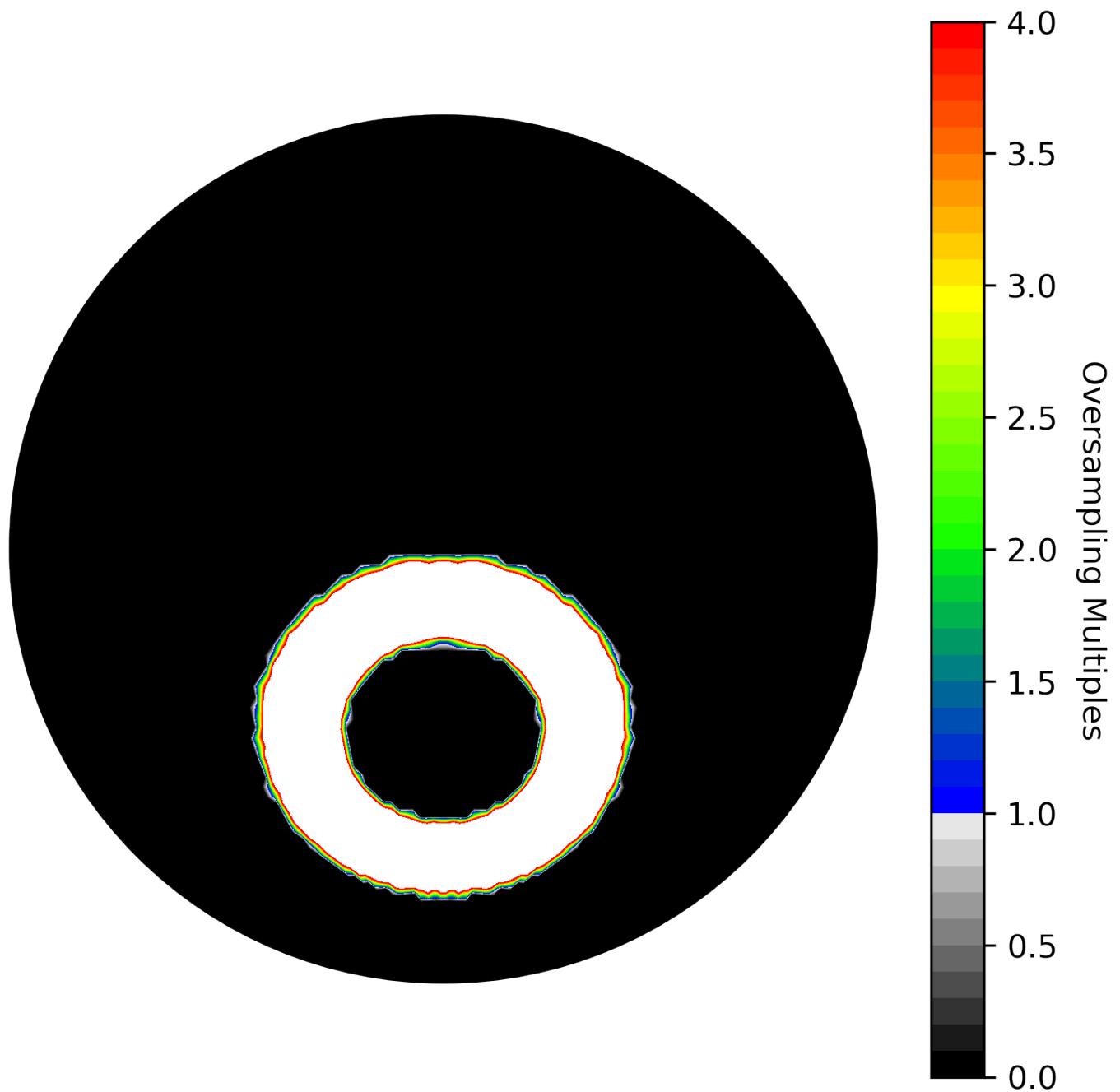


Figure 34: Sample Caption

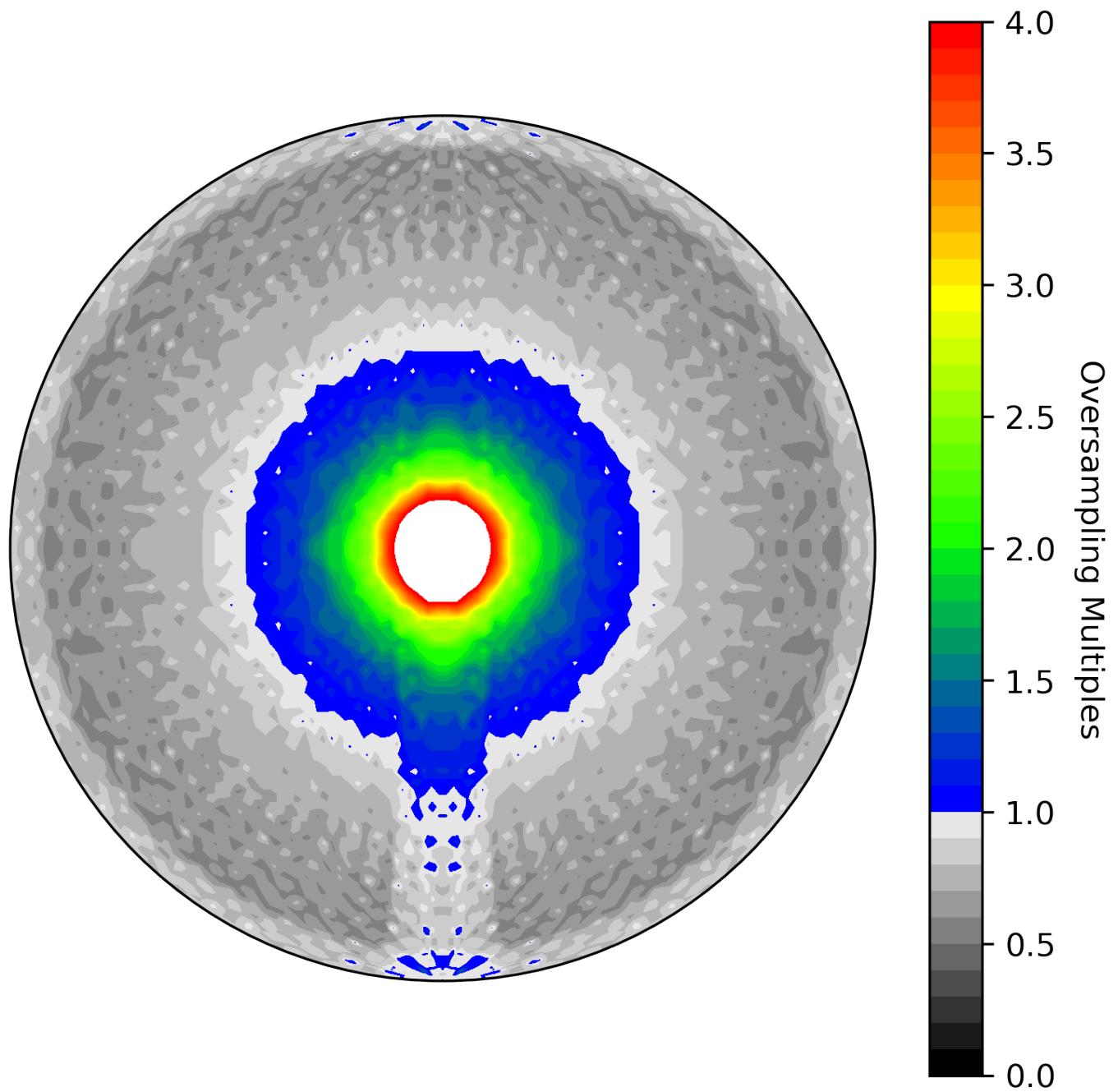


Figure 35: Sample Caption

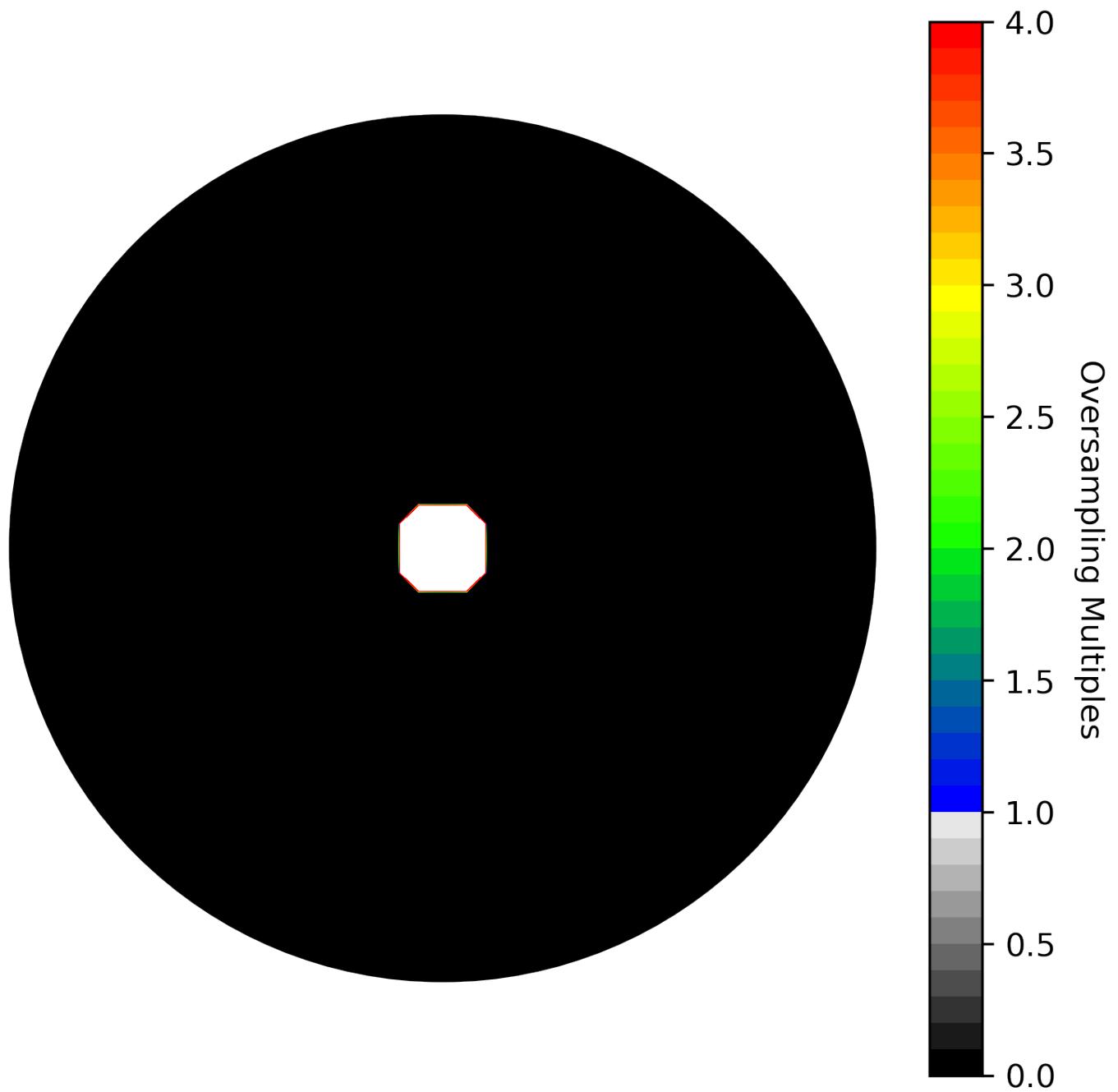


Figure 36: Sample Caption

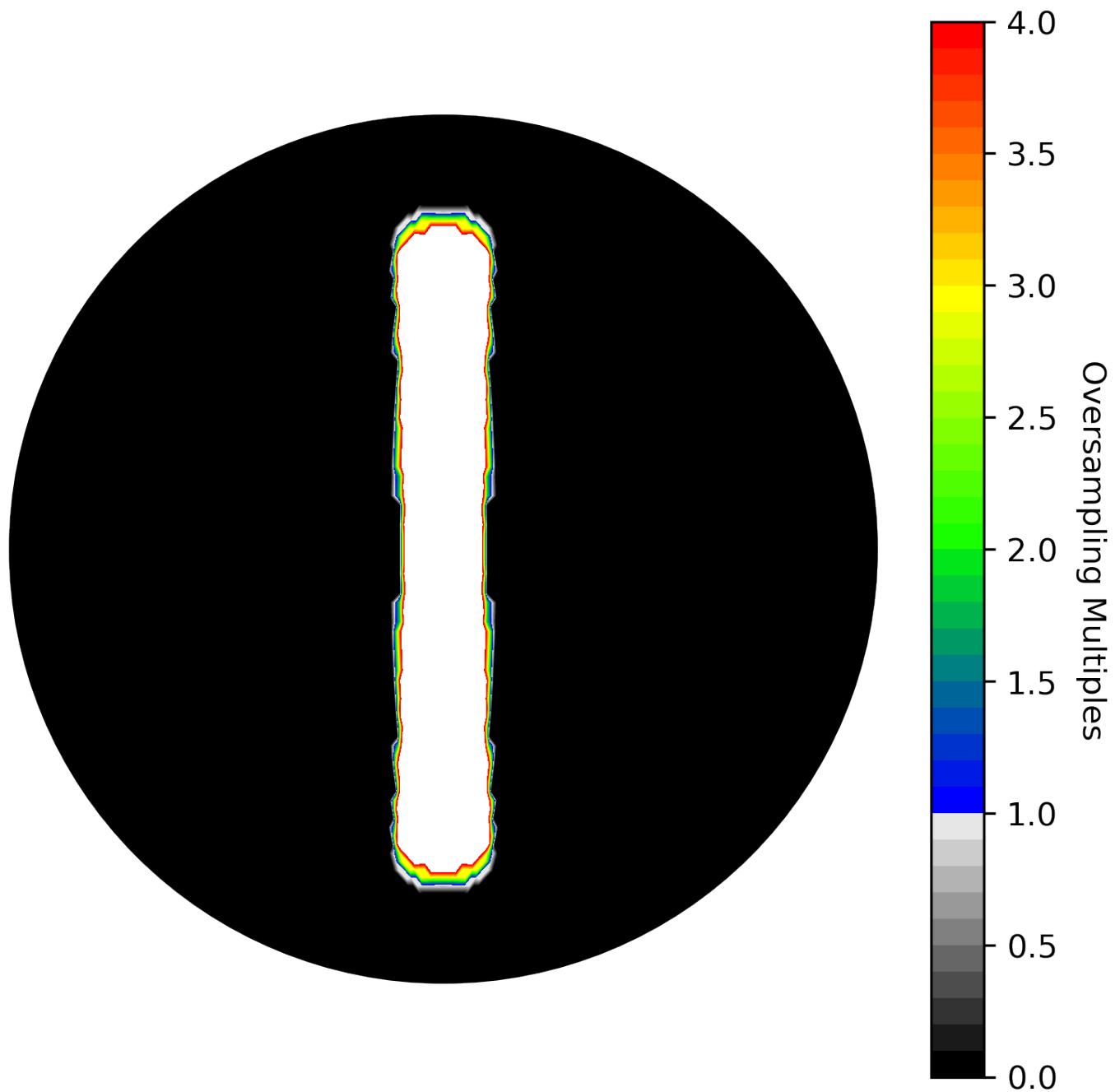


Figure 37: Sample Caption

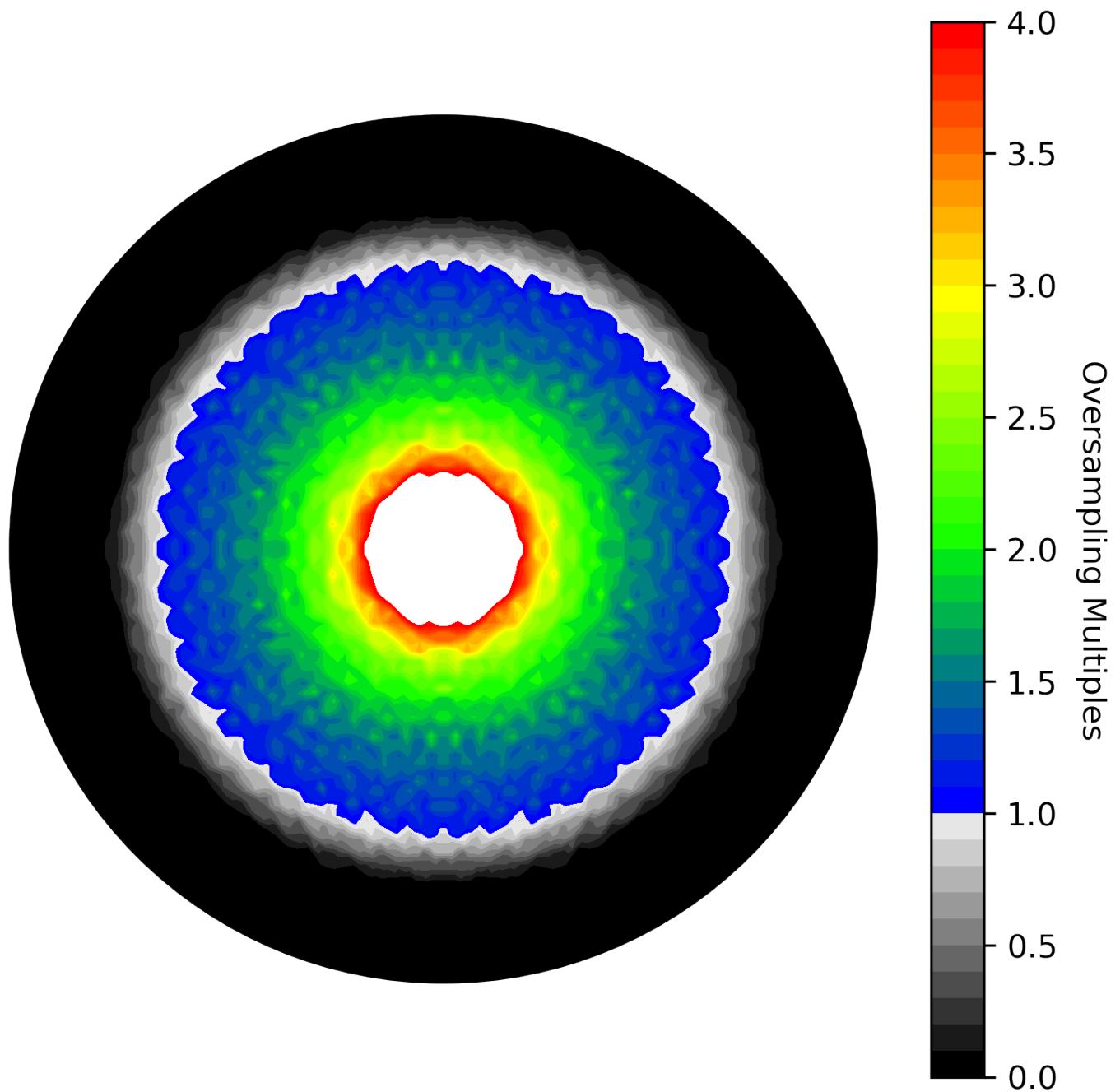


Figure 38: Sample Caption

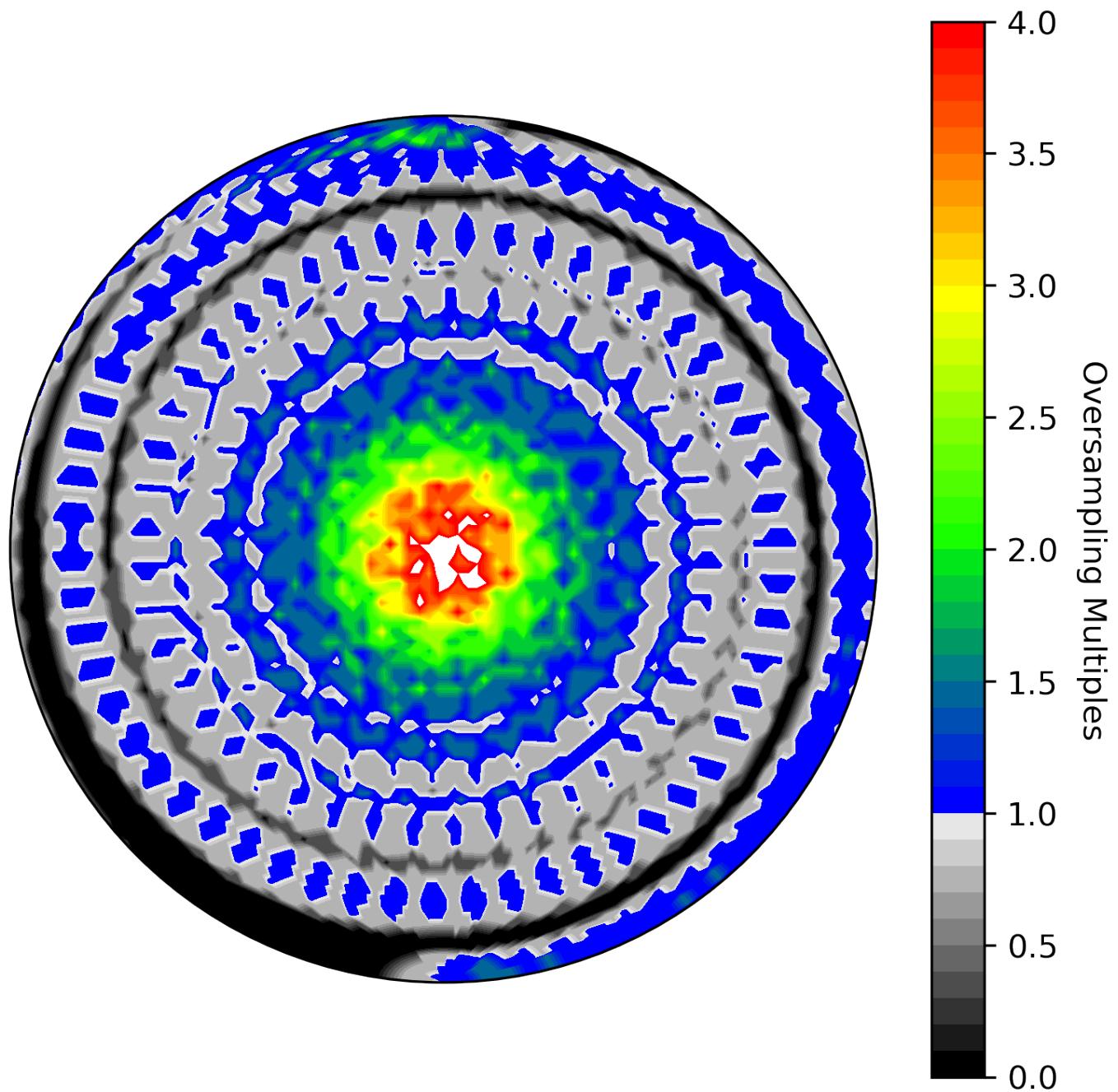


Figure 39: Sample Caption

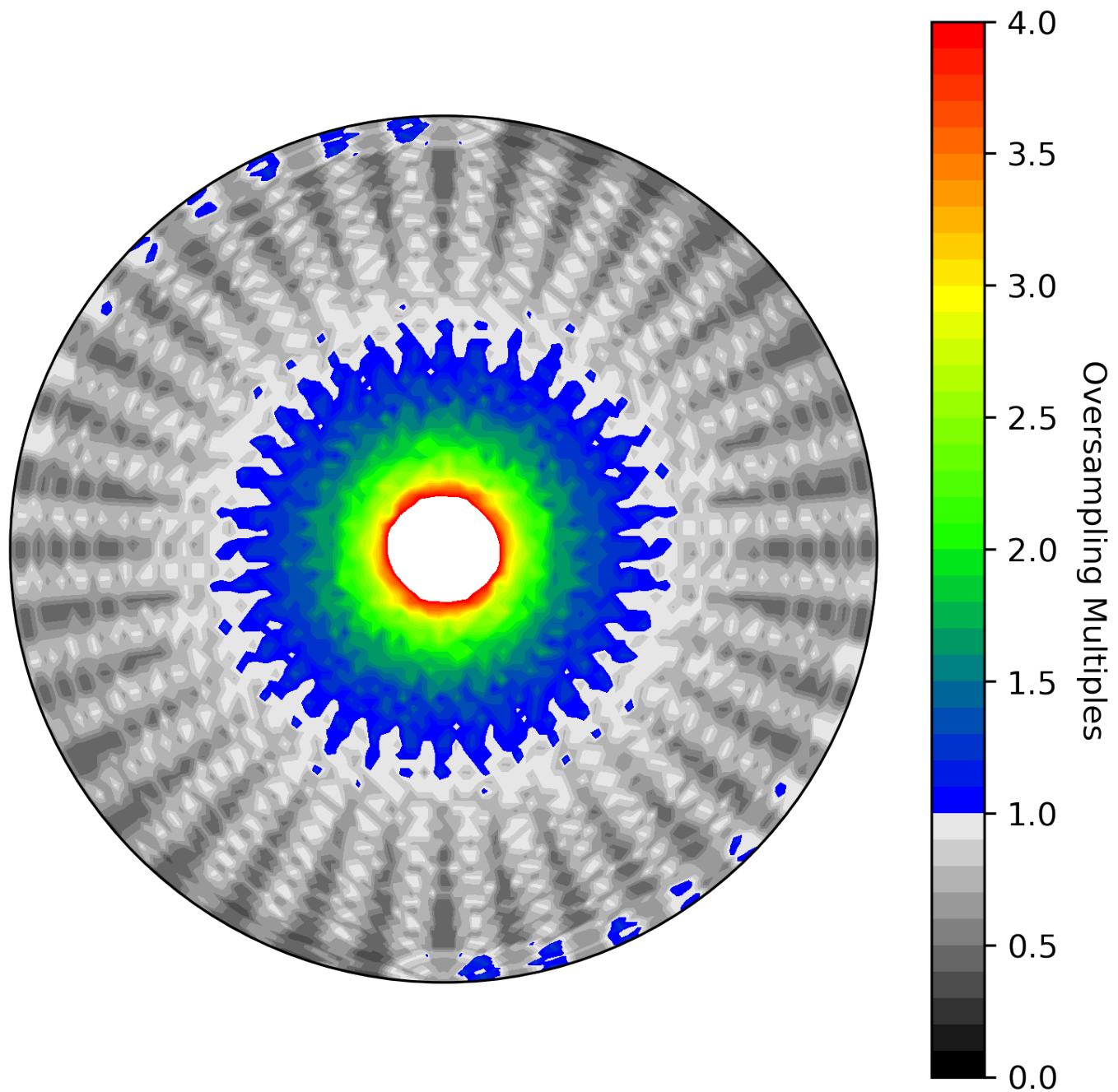


Figure 40: Sample Caption

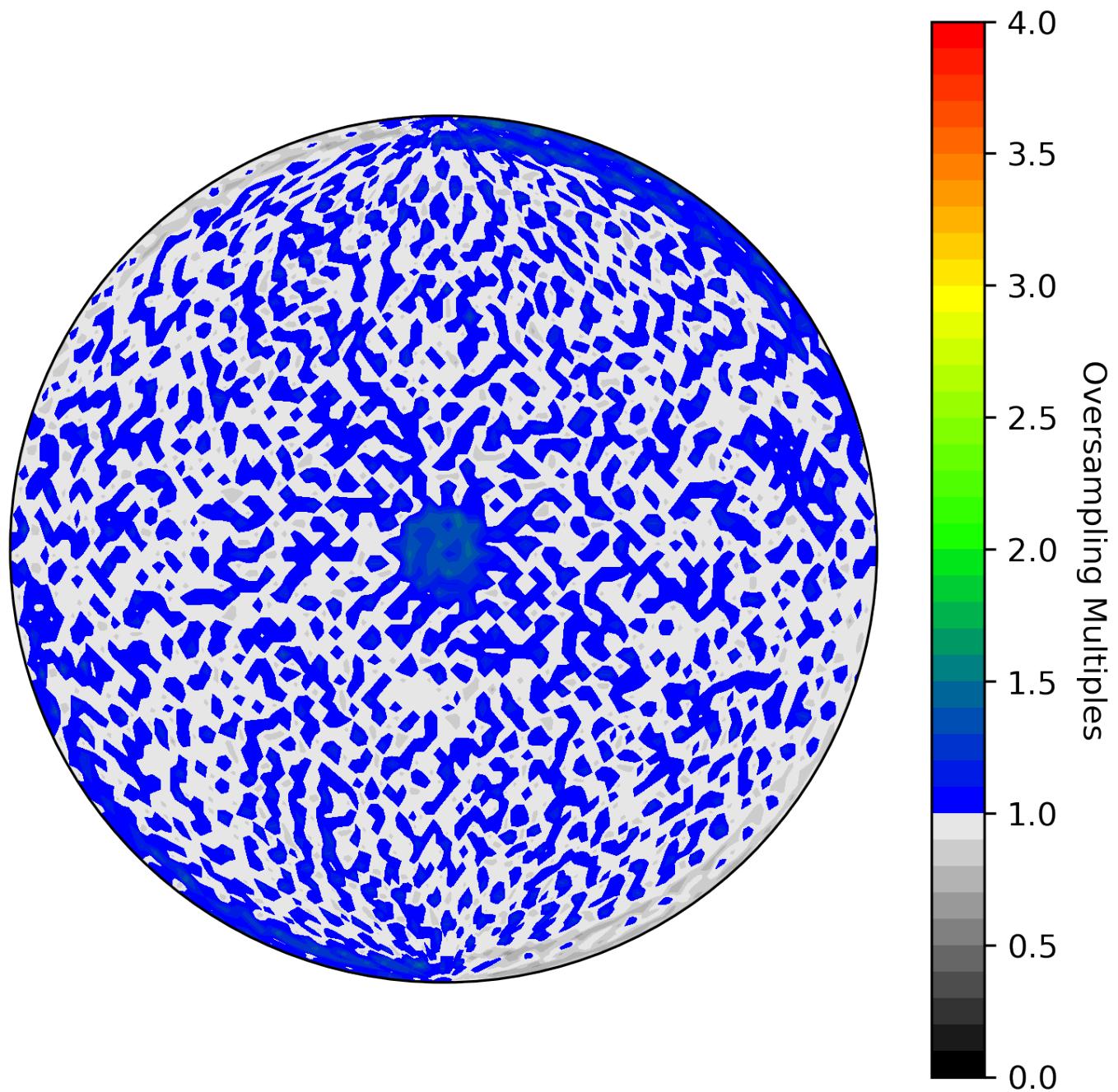


Figure 41: Sample Caption

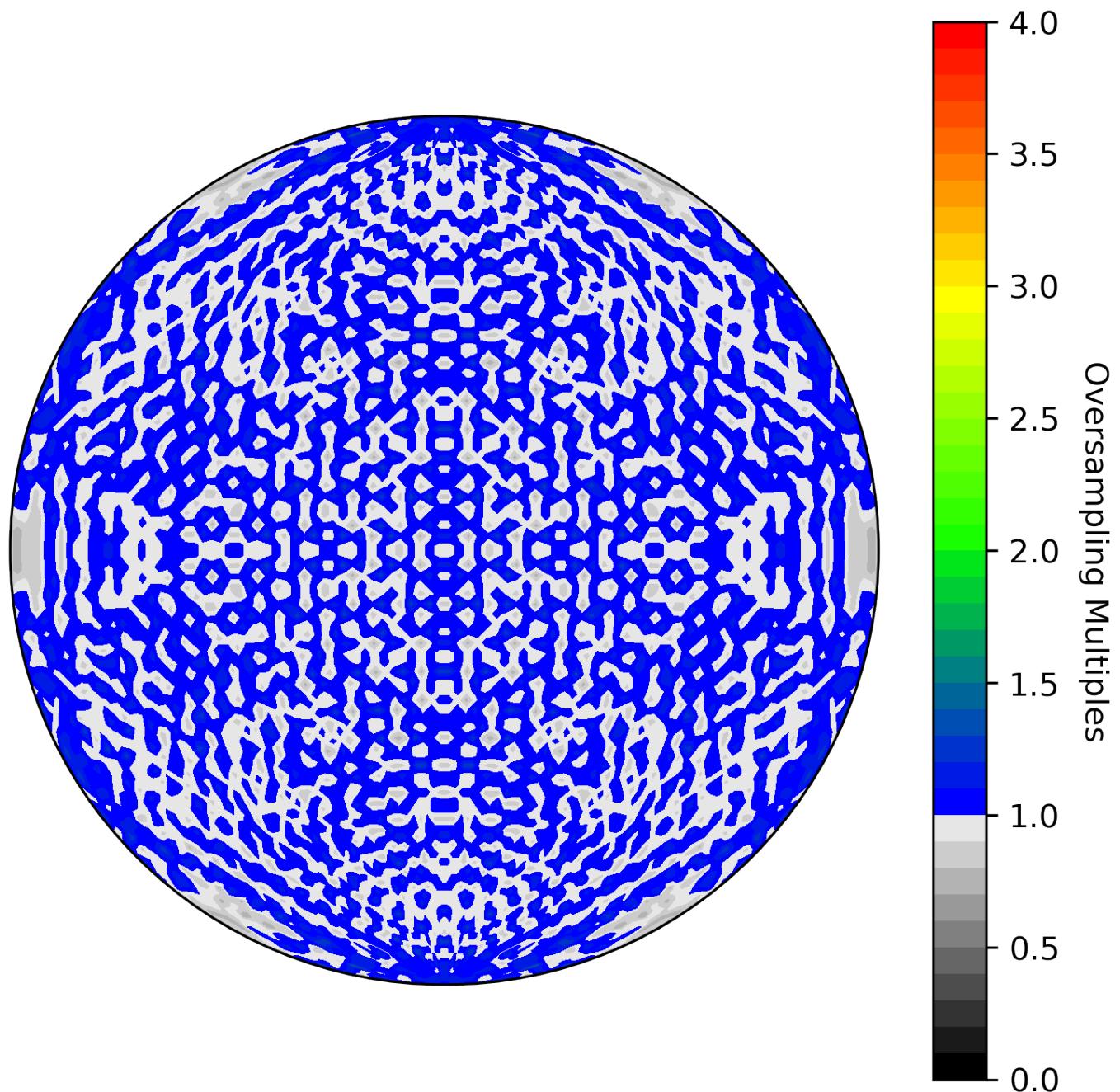


Figure 42: Sample Caption

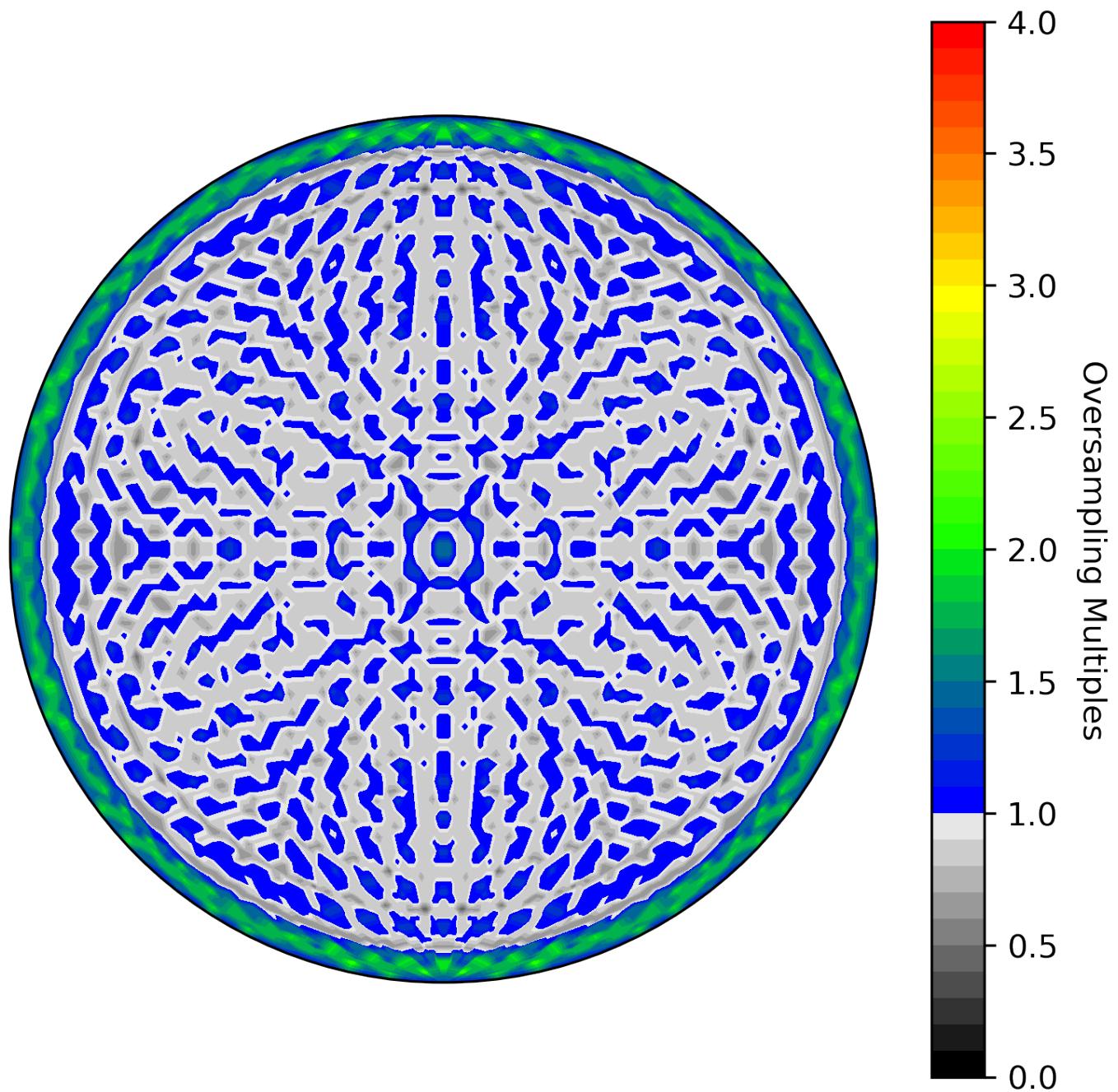


Figure 43: Sample Caption

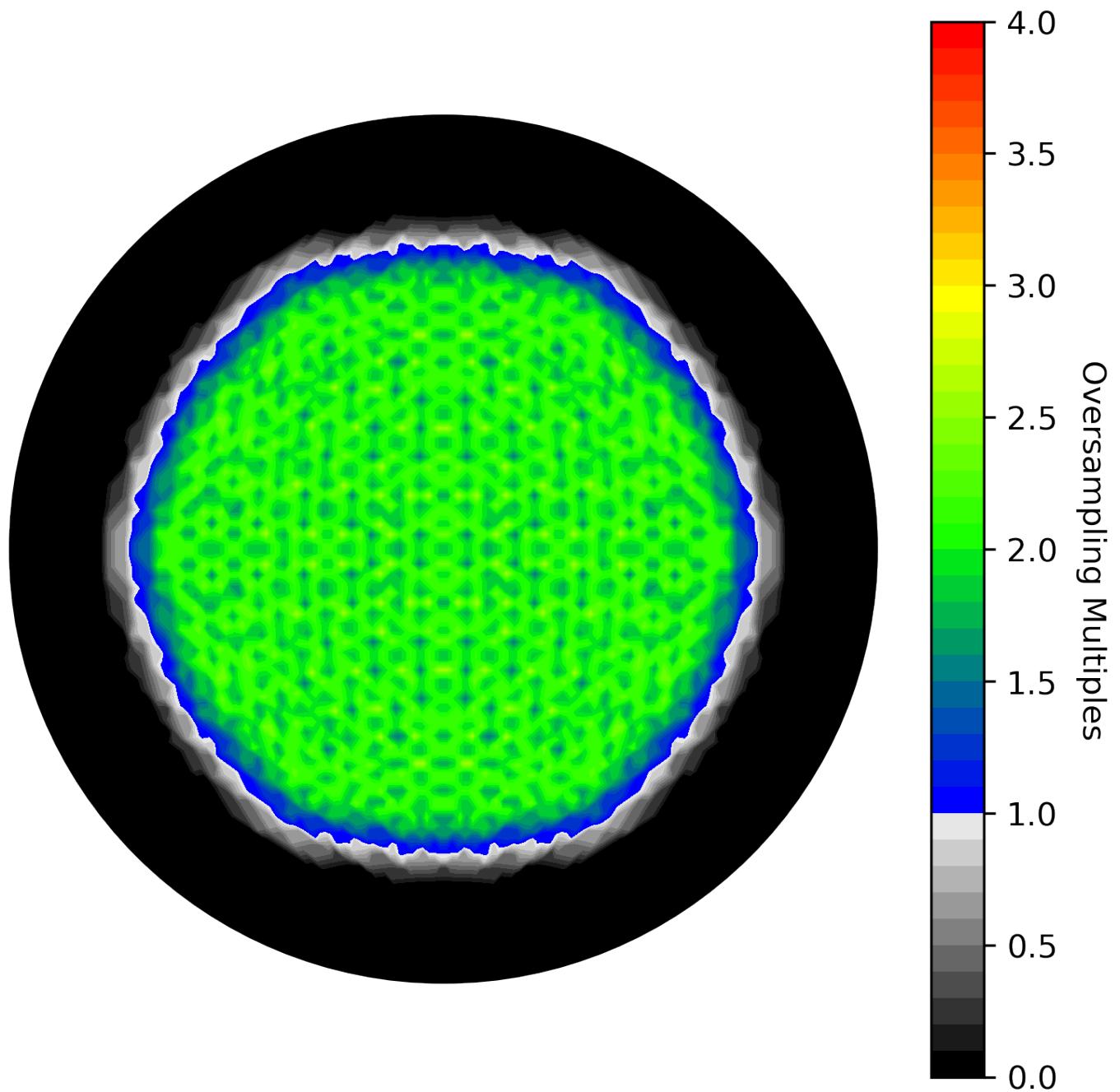


Figure 44: Sample Caption

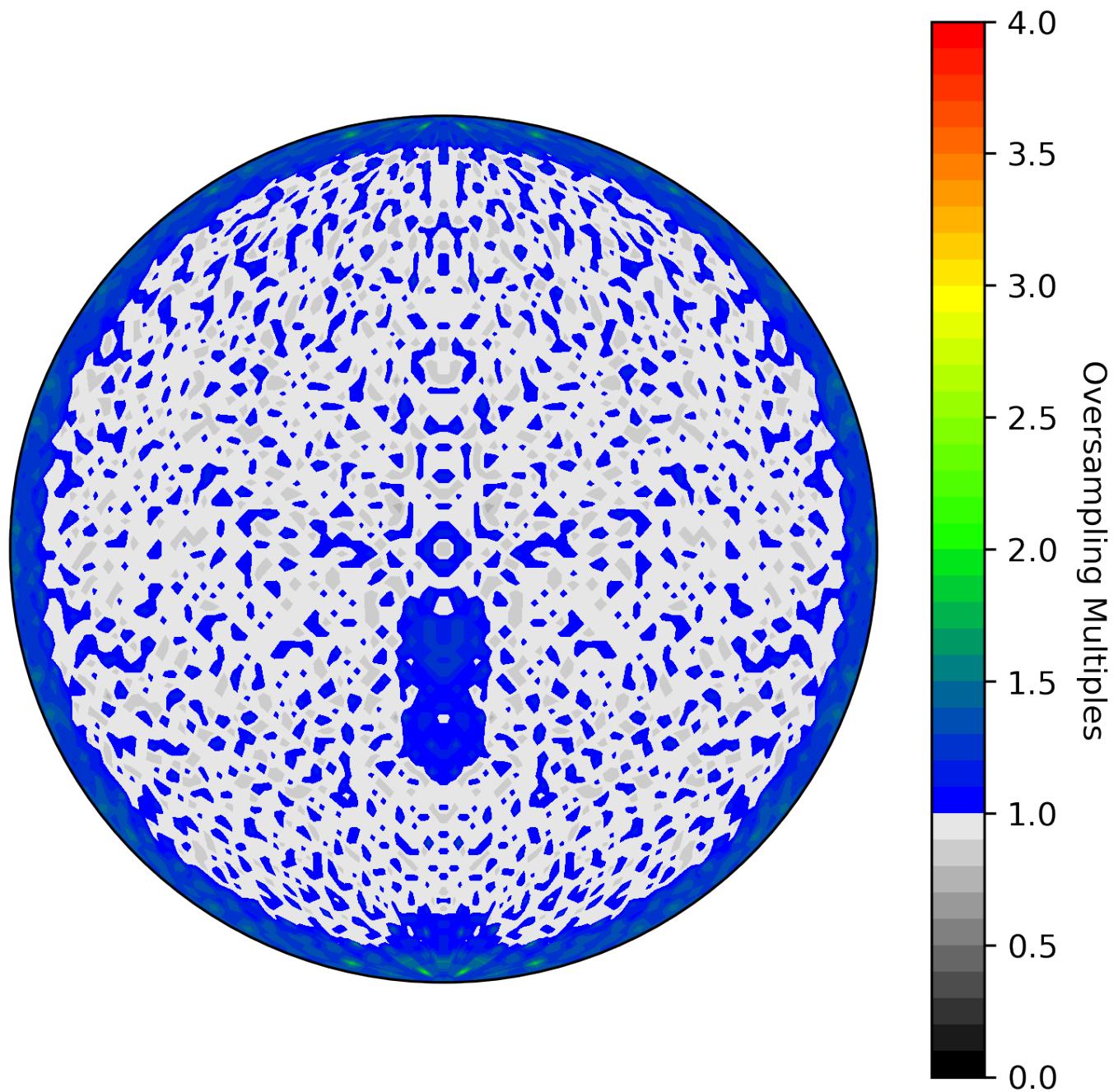


Figure 45: Sample Caption

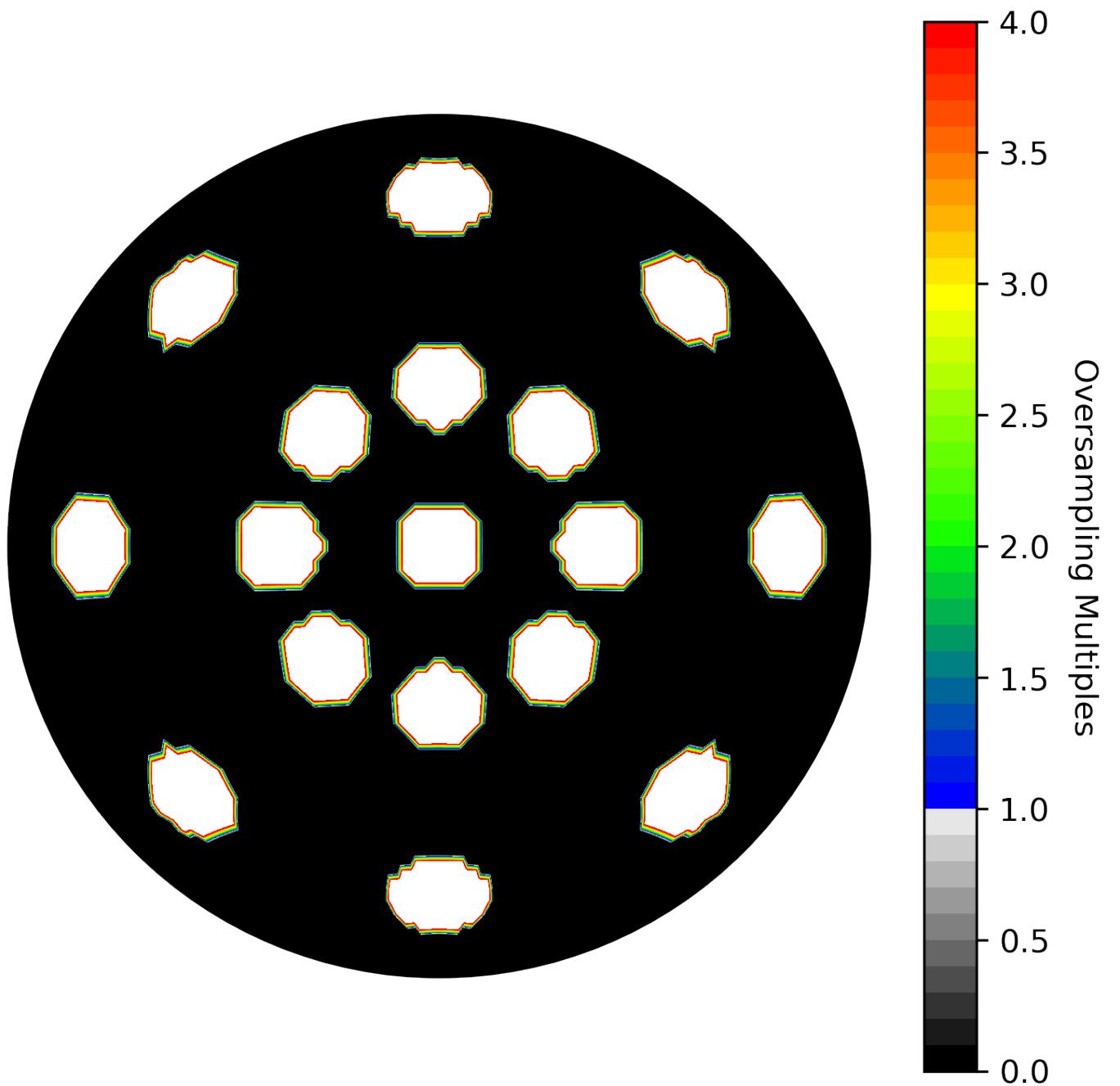


Figure 46: Sample Caption